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LABORATORY PLASMA PROBE STUDIES

Walter J. Heikkila



Plasma laboratory experiments and data reduction continued during this reporting period. This report summarizes some of the data obtained on electrostatic resonances observed in the plasma generated at The University of Texas at Dallas.

Dr. Rainer Kist\* and UTD personnel utilized a UTD developed digital Langmuir probe plus RF probes to study resonances generated in a collisionless laboratory CO<sub>2</sub>-plasma. Laboratory instrumentation, including the Langmuir probe output, were connected to the PDP 11/45 digital computer which automatically recorded and reduced probe data.

The main body of this report is presented in the following two papers written by Dr. Kist.

Appendix A: Plasma Probe Measurements in a Collisionless Laboratory CO<sub>2</sub>-plasma.

Appendix B: Operation of a Digital Langmuir Probe on Line with a PDP 11/45 Digital Computer

\*On leave at UTD, sponsored by the European Space Research Organization (ESRO), now European Space Agency (ESA).

Plasma Probe Measurements in a  
Collisionless Laboratory CO<sub>2</sub>-Plasma

by Rainer Kist<sup>+</sup>

This memo describes diagnostic experiments performed in a collisionless plasma using CO<sub>2</sub> as working gas. In particular simultaneous measurements that have been performed by means of Langmuir- and RF-probes are presented. A resonance occurring above the parallel resonance in the frequency characteristic of a two electrode system is interpreted as being due to the resonant excitation of electroacoustic waves. The memo represents a part of the accomplishments achieved in the course of a laboratory plasma investigation at the University of Texas at Dallas (UTD).

<sup>+</sup> On leave at UTD, sponsored by the European Space Research Organization (ESRO), now European Space Agency (ESA).



Introduction:

Studies with diagnostic probes in laboratory plasmas have several important advantages as compared to space plasma investigations:

- 1) Systematic variation of the parameters involved with the possibility of measuring over large time intervals and of repeating the measurements .
- 2) Extensive testing of the performance of space plasma probes in a plasma environment prior to a space mission.
- 3) Systematic investigation of specific plasma phenomena with the aim of improving existing or developing new diagnostic methods.
- 4) Extensive investigation of various phenomena such as plasma wave mode generation and propagation, unstable plasma states and nonlinear effects.
- 5) Relatively low cost and short time period needed for realizing a plasma experiment.

The results of such laboratory plasma investigations may provide data for checking on particular theories in plasma physics or have impact upon the understanding in fields like space plasmas (planetary ionospheres, magnetosphere, solar wind etc.) or even (after scaling up the results properly) fusion plasmas.

For the space plasma physicist the laboratory plasma is and will remain a very valuable tool even though in the coming spacelab age the ionosphere itself may be used for particular investigations as a large scale "laboratory" plasma of low density and temperature.

In the piece of work presented here the influence of the electron temperature on the frequency characteristic of the plasma impedance of a two electrode system was investigated. Of particular interest was the resonant excitation of electroacoustic waves within two RF electrodes for different geometries and plasma conditions.

### Experimental System

A stainless steel vacuum chamber, 70 cm long and 50 cm in diameter, has been equipped with a plasma source which uses  $\text{CO}_2$  as working gas. A turbomolecular pump together with a copper shroud which was cooled down to liquid nitrogen temperature provided a background vacuum of about  $10^{-6}$  Torr. Fig. 1 shows the source schematically. The general concept was to produce a discharge plasma in a separate volume  $V_1$  (bell jar) and let it expand into the volume  $V_2$  (chamber) through a diaphragm. During operation typical pressure values were  $10^{-2}$  Torr in volume  $V_1$  and  $10^{-4}$  Torr in volume  $V_2$ . In order to control the pressure gradient and the plasma source performance the diaphragm was an iris which could be varied by means of a feedthrough mechanism. A heated tungsten cathode provides primary electrons for the discharge as well as neutralizing electrons for the ions moving from the discharge region into the tank. A paddle proved very useful in baffling high energetic electrons coming from the discharge.

A set of different plasma probes were installed in the tank, in particular

- a) a conventional Langmuir probe (LP)
- b) a retarding potential analyzer (RPA) and
- c) electrode systems for RF impedance measurements.

Fig. 2 shows schematically the arrangement of the plasma source and the probes in the vacuum system. The probes were mounted on movable high vacuum feedthroughs in order to change their position and/or orientation within the tank.

The RF-measurements presented in this memo were performed with a cylindrical and a spherical two-electrode system ( $E_1, E_2$ ), as shown in Fig. 3. The principle of the RF-measurement is also shown. A swept frequency RF generator provides a signal of constant amplitude within the frequency interval of typically 1 to 25 MHz. The RF-reference voltage  $\underline{U}_R$  at  $E_1$  as well as the test voltage  $\underline{U}_T$  at  $E_2$  are measured and compared as to their complex ratio

$$\underline{U}_T / \underline{U}_R = E + jF$$

by means of a network analyzer hp 8407.

The signals provided by the network analyzer are magnitude

$$\alpha = \left| \frac{\underline{U}_T}{\underline{U}_R} \right| = \sqrt{E^2 + F^2} \quad \text{in dB}$$

and phase  $\varphi = \arctan (F/E)$  in degrees. Magnitude and phase together are a measure for the complex plasma impedance  $Z = X + jY$  between  $E_1$  and  $E_2$ . In case of the spherical system half spheres were used as  $E_1$  and  $E_2$ . Additional half spheres were operated as guard electrodes in order to reduce the influence of the tank walls.

In Fig. 4 are shown current-voltage characteristics of a spherical (diameter: 10 mm) stainless steel Langmuir probe.

The parameter of this set of curves is the bias voltage  $U_1$  of the plasma source heating circuit. It can be seen that the velocity distribution and temperature  $T_e$  of the electrons is markedly influenced by  $U_1$ . In the present case the distribution function is maxwellian in good approximation for  $U_1$ -values of - 2 V, - 3 V and - 4 V. The corresponding  $T_e$ -values are 0.55, 0.53 and 0.52 eV, respectively. For each of these Langmuir curves the magnitude  $\alpha$  measured as function of frequency was plotted on a X-Y-recorder. Fig. 5 shows the corresponding set of curves, which reveals the following essential features:

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- a) above the parallel resonance  $f_p$ , which is in our case (no magnetic field) equal to the plasma frequency  $f_N$ , occurs an additional resonance  $f_z$ , and
- b)  $f_z$  is pronounced most clearly for the case of maxwellian distribution of the electrons with low electron temperature  $T_e$  ( $U_1 = - 2$  V, - 3 V, - 4 V).

This resonance  $f_z$  can be understood in terms of electroacoustic waves (also called electron pressure or Landau waves) which are launched by an RF-source above the plasma frequency. Excitation of this electrostatic type of plasma wave, which is damped with increasing frequency by collisionless or Landau damping, is predominantly responsible for the real part of the impedance of an electrode system immersed into a plasma. For a single electrode this real part would decrease monotonically with increasing frequency. For a two electrode system ( $E_1, E_2$ ) as used in our experiment, however, a characteristic electrode distance  $d$  can be defined (distance between inner and outer cylinder or between two spheres). In this case the electroacoustic wave can produce a standing wave pattern between  $E_1$  and  $E_2$ . This is expected to occur essentially at eigenfrequencies of the system {electrodes-plasma} for which the wavelength  $\lambda_{ea}$  (or integer multiples of it) matches the distance  $d$ .

To check this interpretation we start with the Bohm/Gross (1959) dispersion relation for these plasma waves

$$\omega^2 = \omega_N^2 + (3KT_e/m_e) \cdot k^2 \quad (1)$$

Here  $\omega$  is the angular RF-frequency,  $\omega_N$  the angular plasma frequency,  $K$  is Boltzmann's constant,  $m_e$  the electron mass and  $k = 2\pi/\lambda_{ea}$  the electroacoustic wave number. Equation (1) gives the wavelength  $\lambda_{ea}$  at the resonance frequency  $f_Z = \omega_Z/2\pi$ :

$$\frac{\lambda_{ea}}{m} = 0.7263 \frac{\sqrt{KT_e/eV}}{\frac{f_N}{\text{MHz}} \sqrt{\frac{f_Z^2}{f_N^2} - 1}} \quad (2)$$

Applied to the measurements of Fig. 5 we get the following table 1:

Table 1

$U_1/V$	$T_e/eV$	$f_Z/f_N$	$\lambda_{ea}/mm$
- 1	.61	1.40	56
- 2	.55	1.34	54
- 3	.53	1.31	56
- 4	.52	1.30	52
- 5	.65	1.32	54
- 6	.85	1.38	54

The distance of the cylindrical electrodes is  $d = 38$  mm. Due to the cylindrical geometry (equation (1) is strictly valid for plane waves), to the ion sheath, and possible inhomogeneous plasma distribution within the electrodes one cannot expect



an absolute agreement between  $\lambda_{ea}$  and  $d$ . But we have as an essential result, that the ratio  $\lambda_{ea}/d$  is constant within a few percent for all combinations ( $f_N$ ,  $f_Z$ ,  $T_e$ ) that occur in the set of curves of Fig. 5.

Theoretical work done by Whale (1963), Batmain (1965) and Lin/Mei (1970) shows that excitation of electroacoustic waves is reduced by the presence of an ion sheath. On the other hand collapsing the ion sheath by changing the electrode bias potential to the plasma potential leads to electron absorption so that damping of the electroacoustic wave is to be expected, *too*. Thus varying the electrode DC-potential  $U_{DC}$  from negative (ion sheath extended) to positive (ion sheath "collapsed"), a value for  $U_{DC}$  should occur for which the resonance at  $f_Z$  is best pronounced.

The curves of Fig. 6, where the potential  $U_{DC}^T$  of the test electrode  $E_2$  was varied, exhibit exactly this behaviour and thus seem to confirm the interpretation for the  $f_Z$ -resonance suggested above.

Measurements with the spherical electrode system also show the resonance  $f_Z = f_{Z1}$  as can be seen from Fig. 7. In this case the distance  $d$  of the two spheres was varied. In case of the large distance  $d = 92.8$  mm a second resonance  $f_{Z2}$  above  $f_{Z1}$  occurs. These measurements were analyzed on grounds of a theory by Chasseriaux et al. (1972), in which the potential of an oscillating point charge in a warm isotropic plasma is calculated using kinetic plasma theory. The results predict resonances of the potential and hence of the plasma impedance of a spherical system essentially at those frequencies, at which the wavelength  $\lambda_{ea}$  (or integer multiples) equals the distance  $d$  between the spheres. As to our experiment we thus have to check, if the measured values for  $d$ ,  $f_{Z1}$  (and  $f_{Z2}$ ) and  $f_N$  lead to the same electron temperature. The result of this analysis is presented in table 2.

Table 2

<u>d/mm</u>	<u><math>f_{Z1}/f_N</math></u>	<u><math>T_e/eV</math></u>
92.8*	1.11	.44
83.8	1.11	.43
74.8	1.14	.45
65.8	1.20	.53

Again the essential result is that all cases lead in fact within a few percent to the same mean temperature  $T_e = 46$  eV. In case of  $d = 65.8$  mm the error in  $T_e$  is relatively large due to the larger error in reading the resonance frequency  $f_Z$ . The mean value for  $T_e$  is indicated by the straight line drawn into the corresponding Langmuir characteristic of Fig. 8. The additional resonance at  $f_{Z2}$  leads, applying the theory of Chasse-rioux et al., to the value  $T_e = .51$  eV. This value still seems to be reasonable in view of several error sources like reading error for  $f_{Z2}$ , deviation of the velocity distribution of the electrons from maxwellian, presence of an ion sheath around the electrodes etc.

The experiments presented here show that a system of two RF-electrodes lead to additional resonances of the impedance characteristic above the plasma frequency which can be understood in terms of resonant excitation of electroacoustic waves.

Systematic and more detailed investigations of the plasma impedance of two electrode systems will be performed in the big plasma chamber at IPW<sup>†</sup>/Freiburg. The importance of the additional resonance  $f_Z$  relies on two aspects:

- 1) knowing the distance  $d$  and the plasma frequency  $f_N$ ,  $f_Z$  allows in principle to deduce the electron temperature  $T_e$ .

<sup>†</sup> IPW = Institut für Physikalische Weltraumforschung.



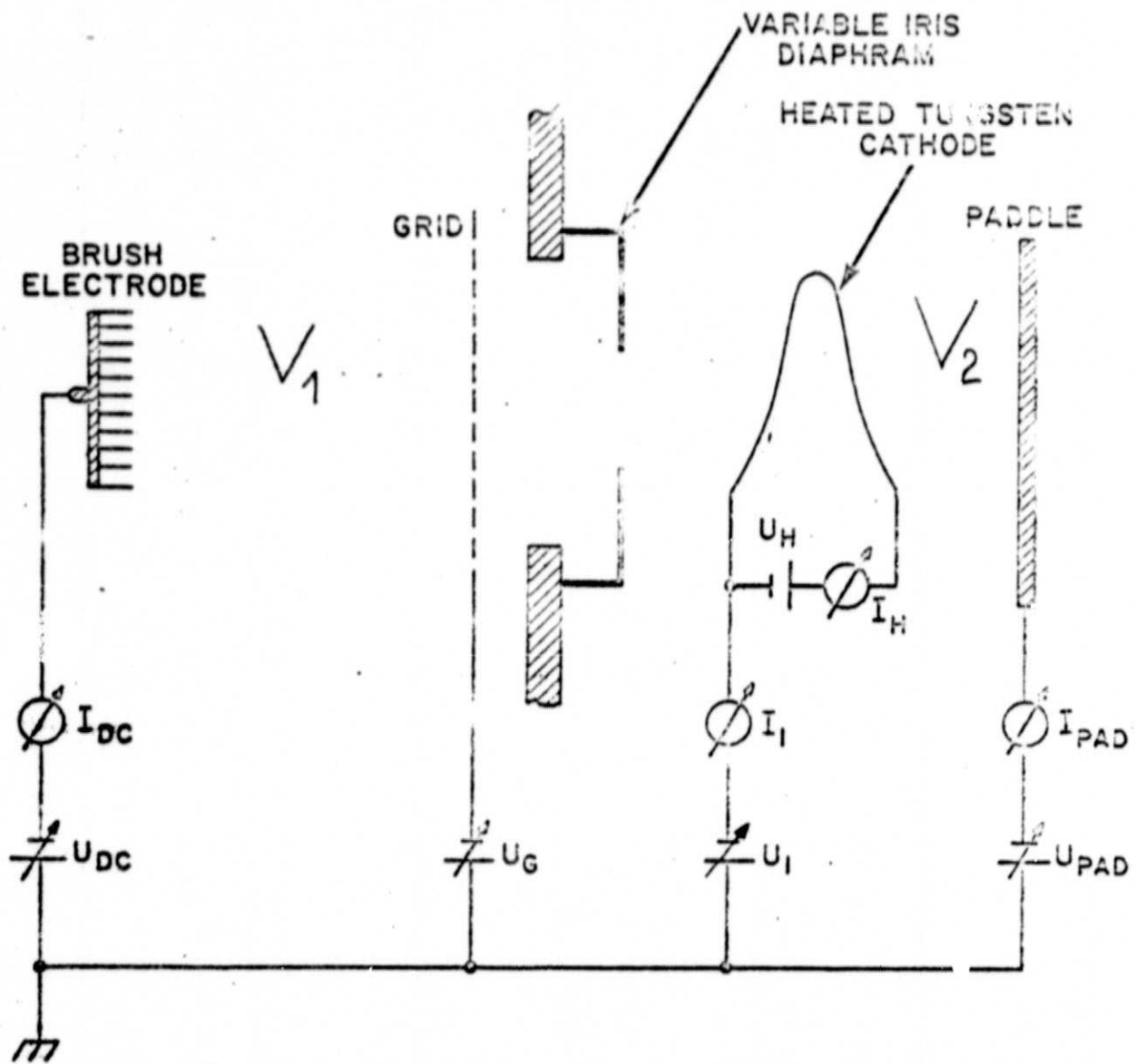
- 2) This method would allow to determine  $T_e$  with high temporal resolution ( $10^{-1}$  to about  $10^{-2}$  sec) which would be of particular value for diagnostic measurements in space plasmas as well as non stationary laboratory plasmas.

Acknowledgement:

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PLASMA SOURCE

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FIG 1

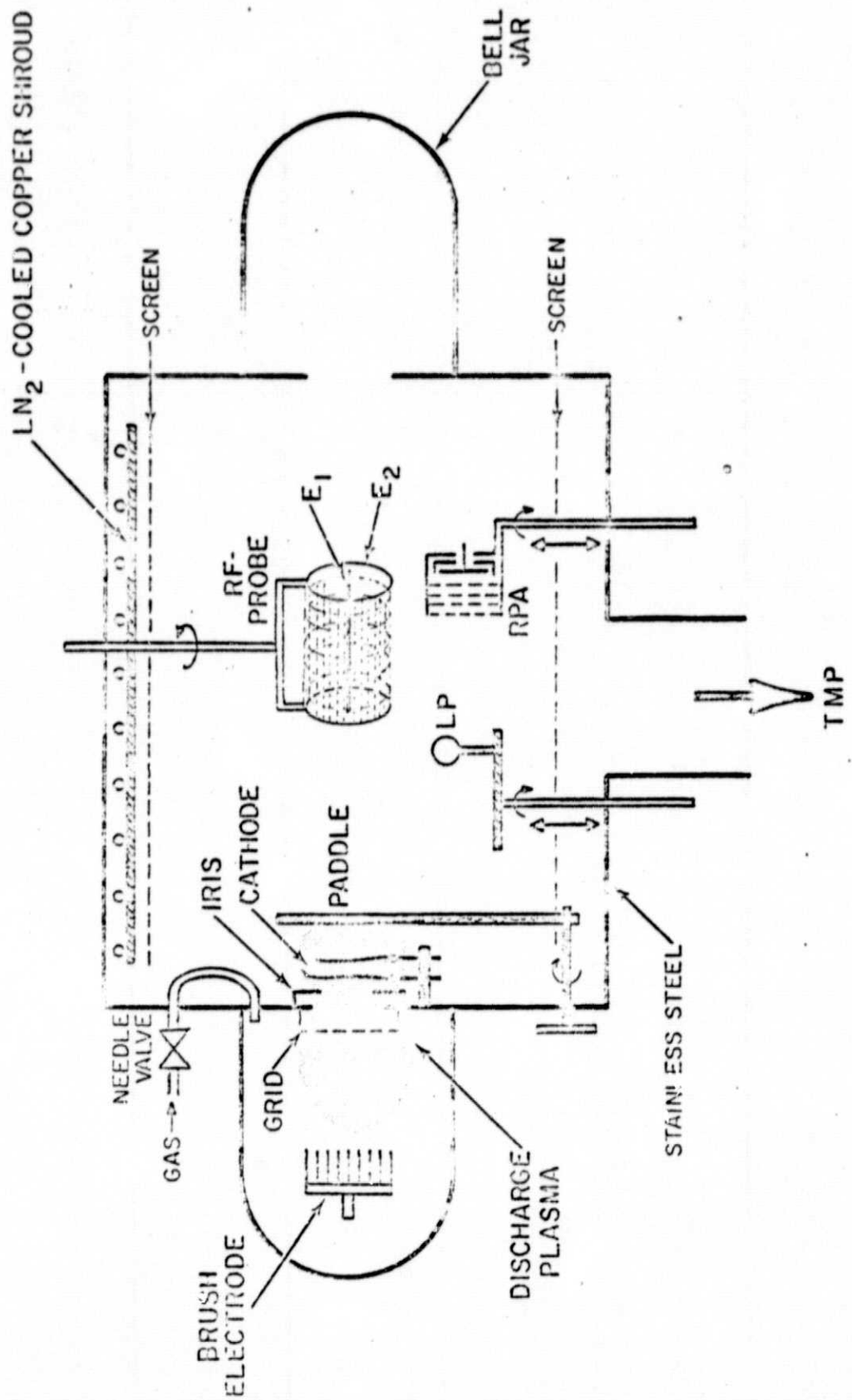
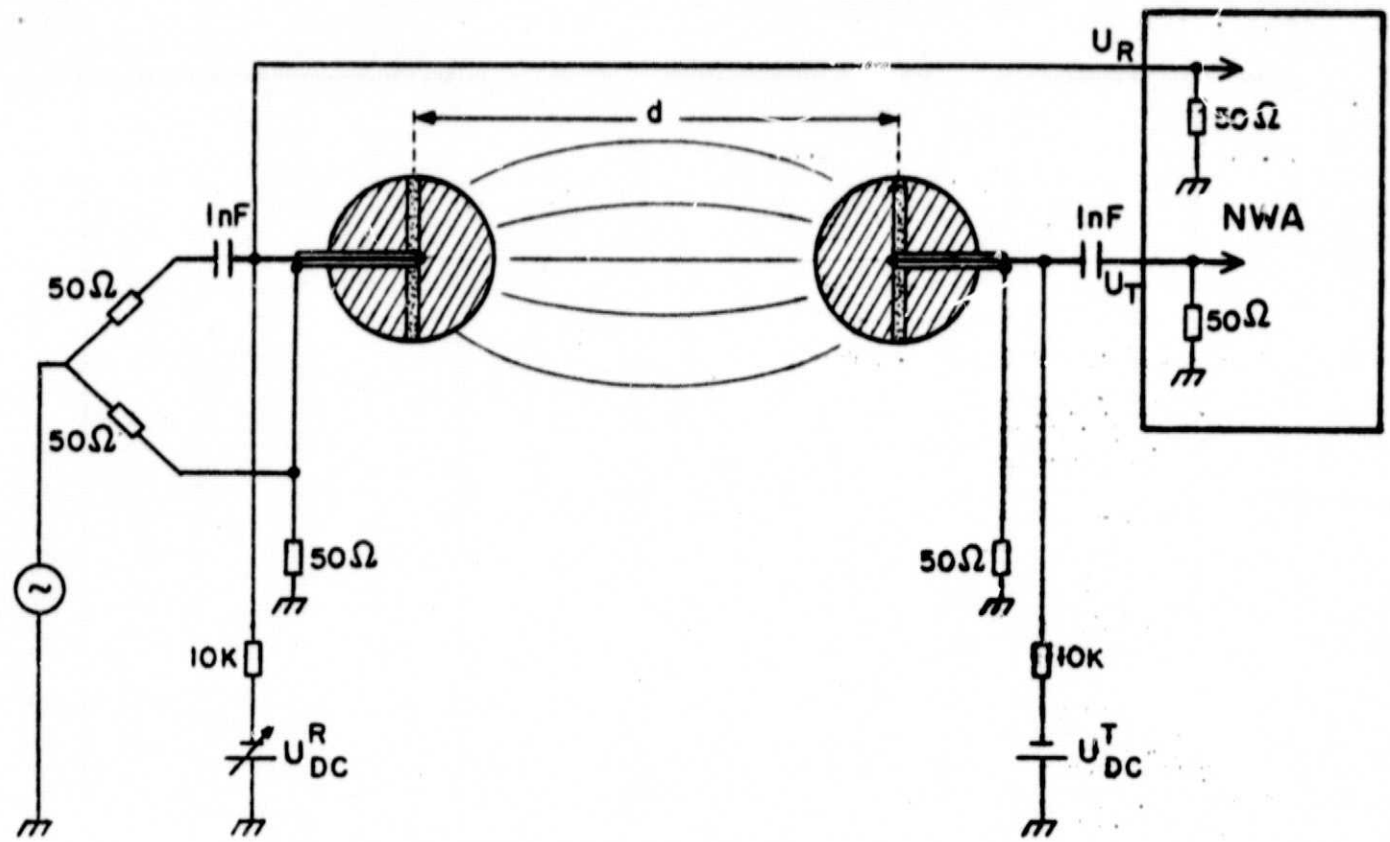
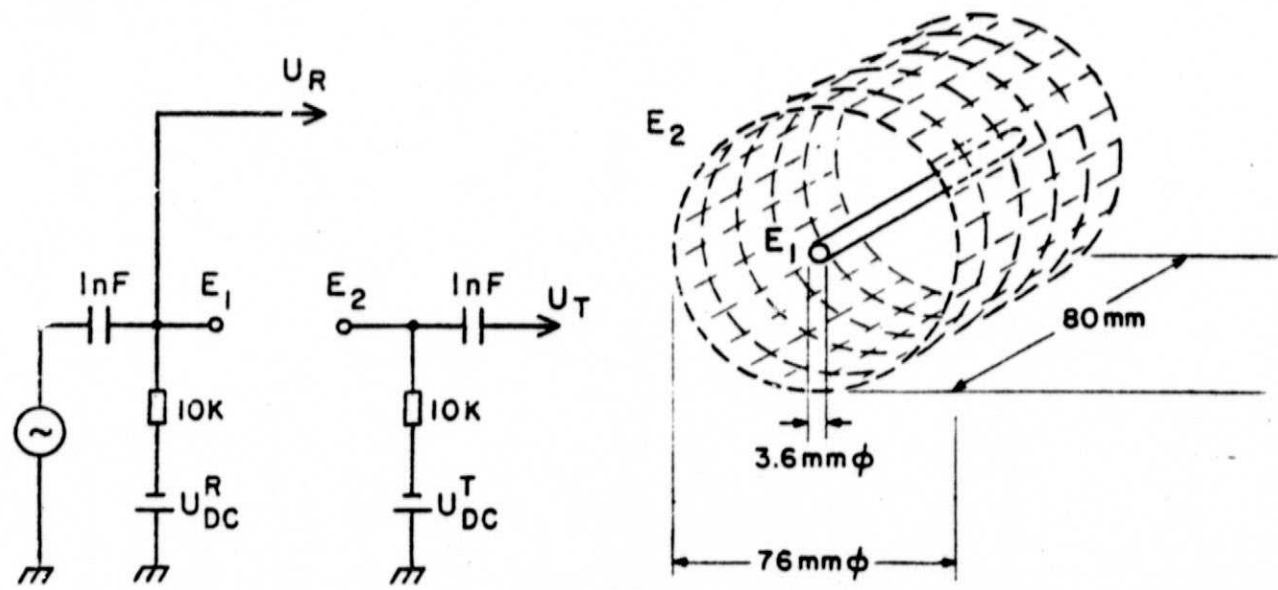


FIG 2

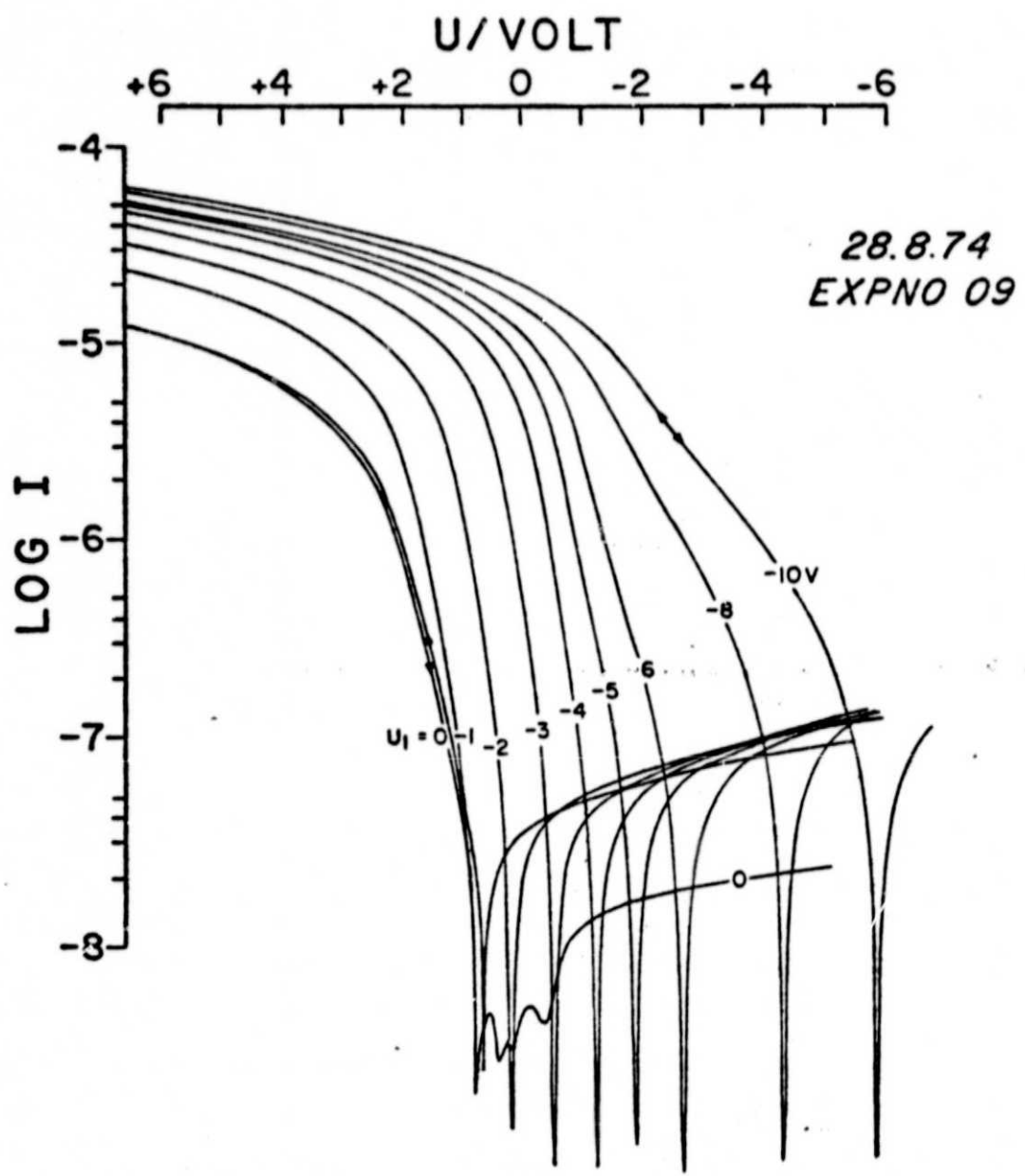


**SPHERICAL RF - PROBE**  
 DIAMETER OF BOTH SPHERES: 17.8 mm



**CYLINDRICAL RF - PROBE**

FIG 3

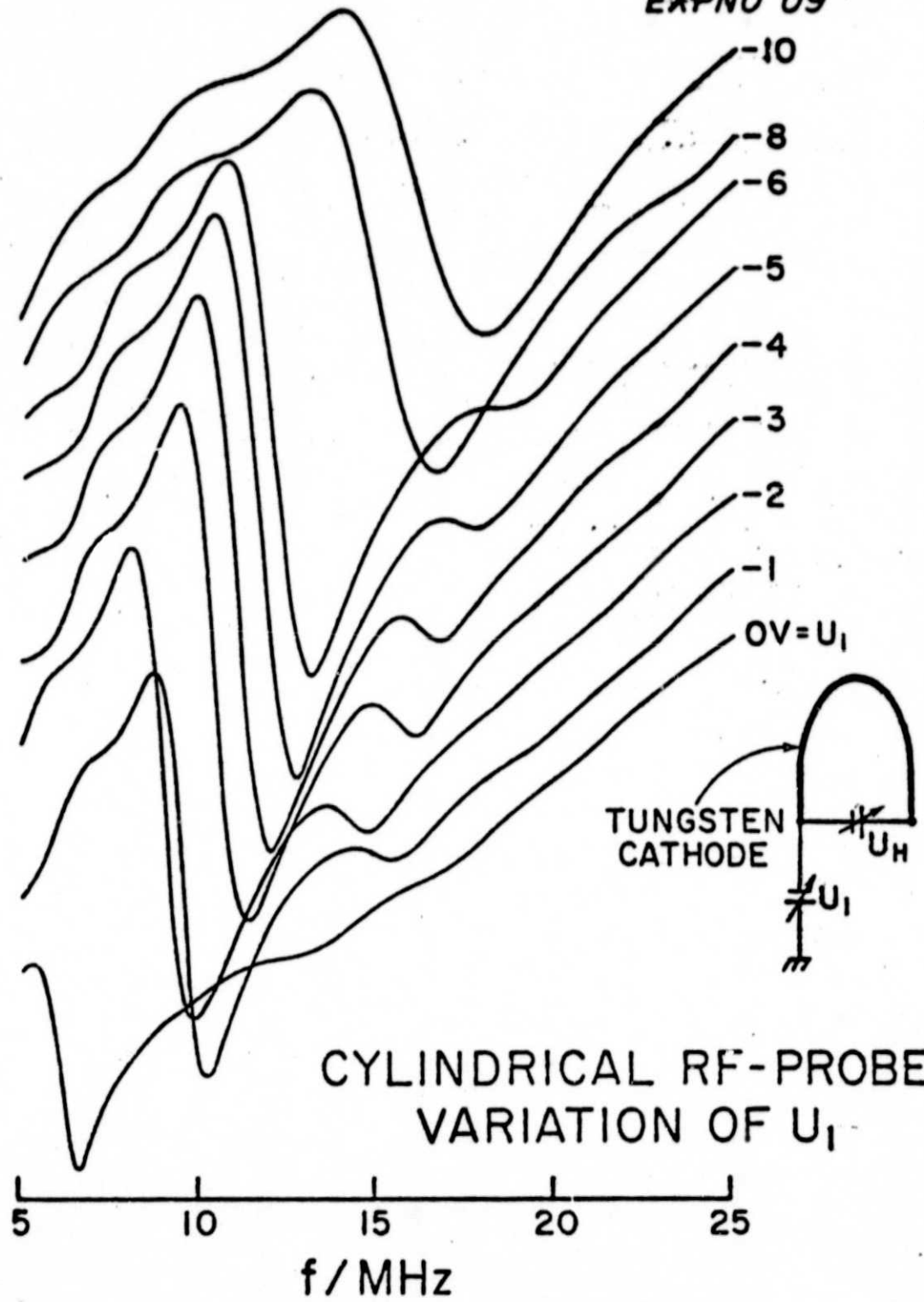


SPHERICAL LANGMUIR PROBE  
STAINLESS STEEL  
DIAMETER 10mm  
VARIATION OF  $U_1$

FIG 4

28.8.74  
EXPNO 09

10dB

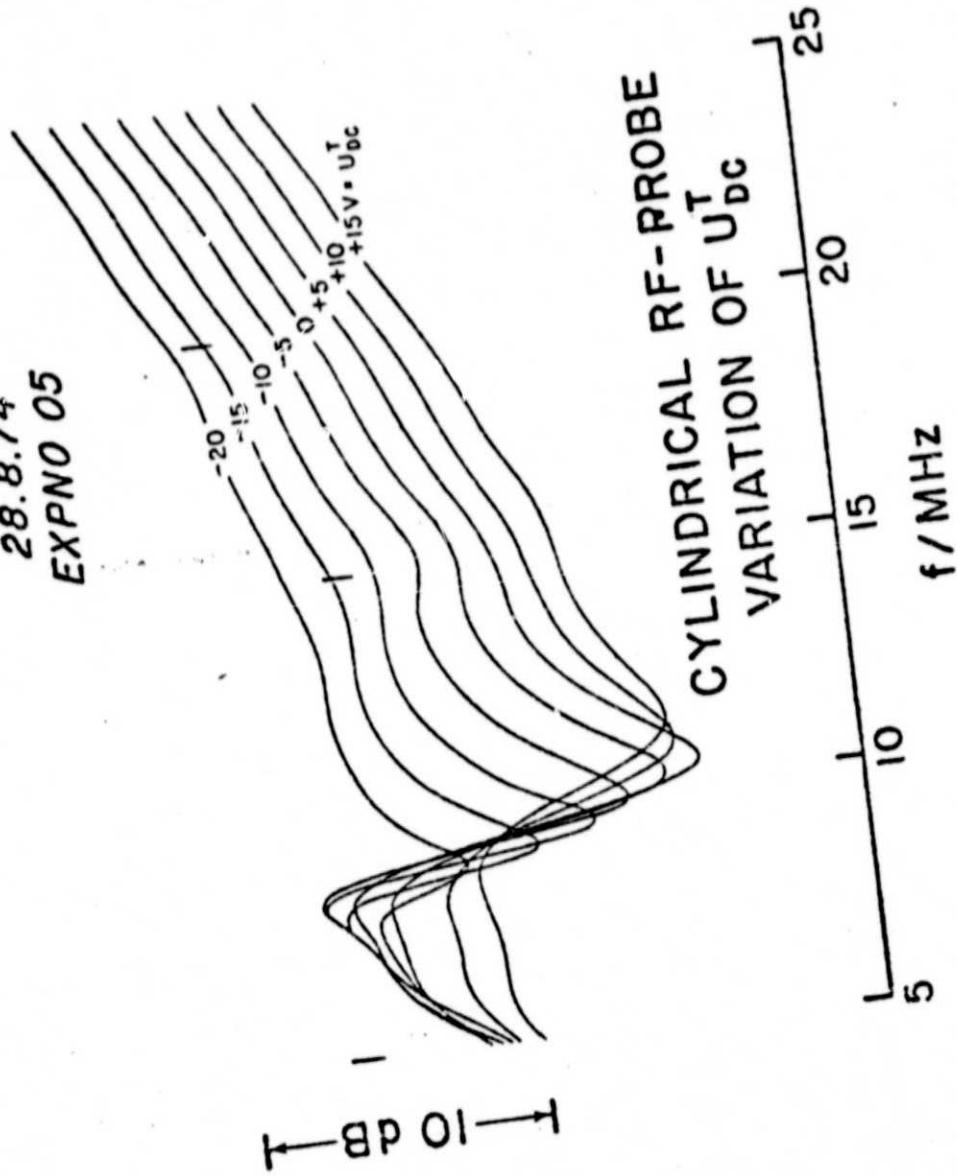


CYLINDRICAL RF-PROBE  
VARIATION OF  $U_1$

FIG 5



28.8.74  
EXPNO 05



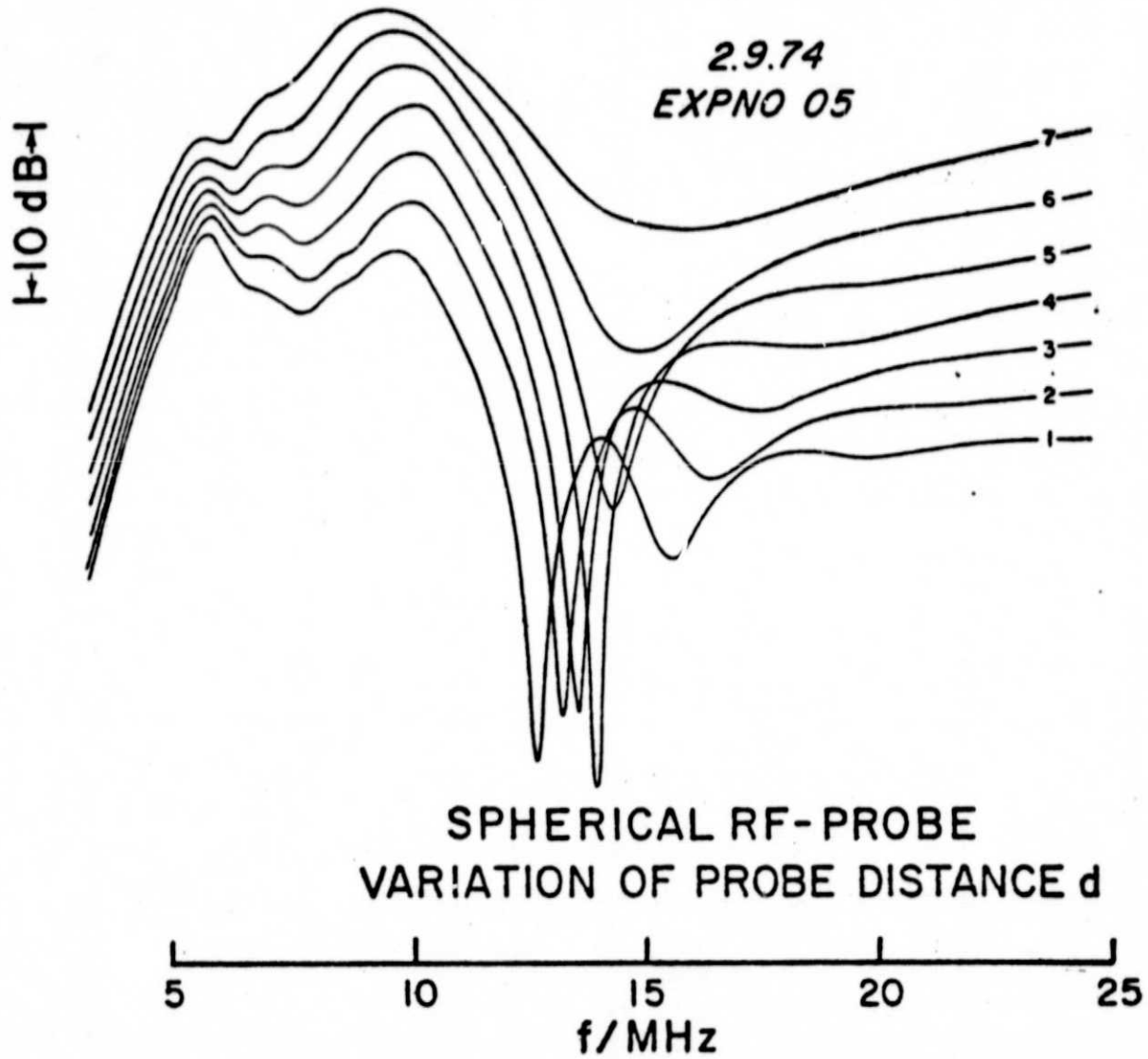
CYLINDRICAL RF-PROBE  
VARIATION OF  $U_{dc}^T$

f / MHz

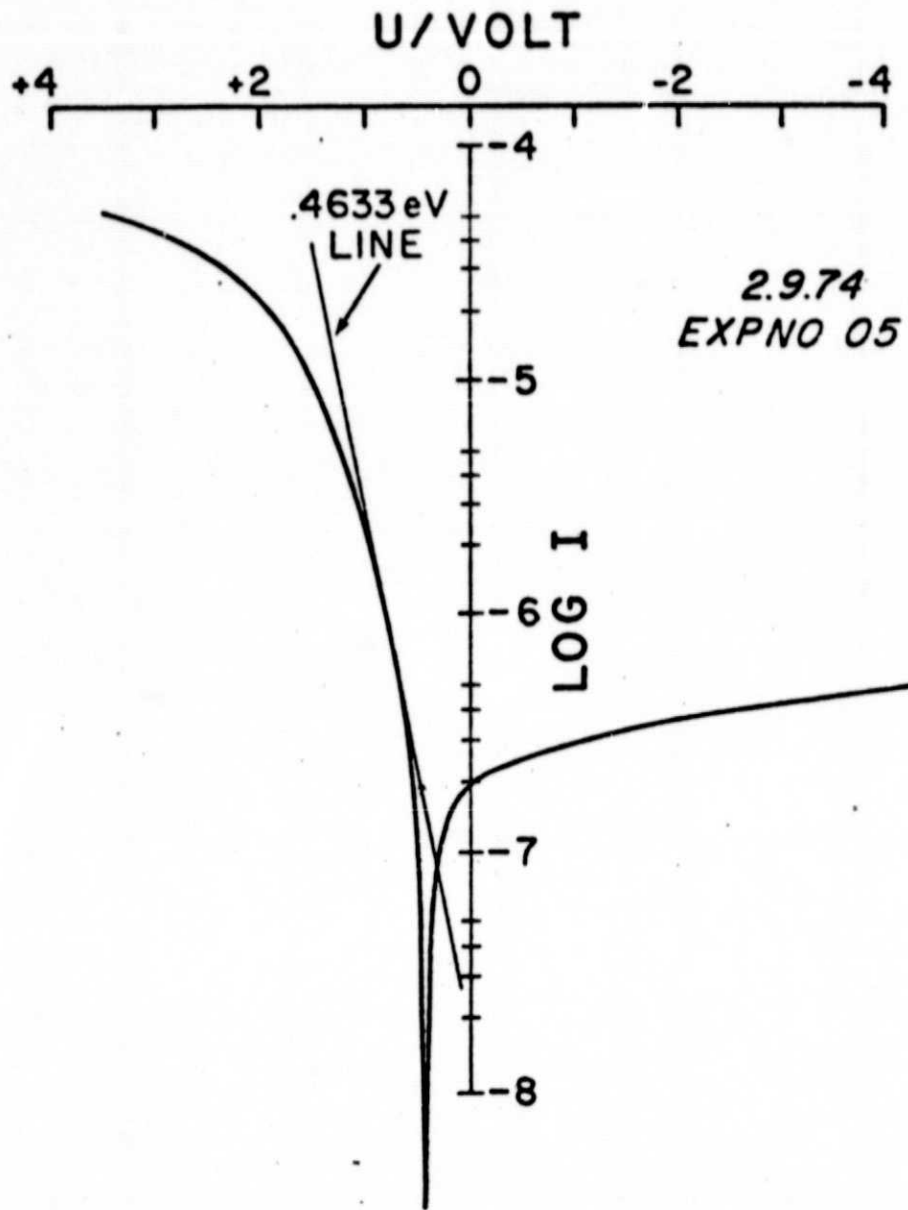
FIG 6

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NO.	1	2	3	4	5	6	7
d/mm	92.8	83.8	74.8	65.8	56.6	47.6	38.8



*FIG 7*



SPHERICAL LANGMUIR PROBE  
STAINLESS STEEL  
DIAMETER :0mm

FIG 8

OPERATION OF A DIGITAL LANGMUIR PROBE  
ON LINE WITH A PDP 11/45 DIGITAL COMPUTER

by

RAINER KIST\*

This memo describes the concept and the performance of the Digital Langmuir Probe (DLP) experiment, the necessary interface electronics to the computer and the associated software. The system was set up to provide a flexible diagnostic tool for the laboratory plasma facility at the University of Texas at Dallas (UTD). The memo summarises a part of the accomplishments achieved in the course of a project which deals with production and diagnostics of collisionless laboratory plasmas at UTD.

UTD, September 1974

\*On leave at UTD, sponsored by the European Space Research Organization (ESRO), now European Space Agency (ESA).

## I. INTRODUCTION

Several diagnostic probes such as RF-probe, Retarding Potential Analyzer (RPA) and Langmuir Probes (LP) have been installed in the Laboratory plasma chamber at UTD. Langmuir Probes of different materials (Stainless Steel, Polymorphic carbon) and geometry (spherical, cylindrical) have been used. Fig. 1 shows the arrangement of the probes within the chamber. The detailed description and performance of the plasma source and the probes are the object of a separate memo.

A conventional Langmuir probe electronics makes use of an electrometer amplifier with either a nonlinear (diode) feedback resistor or a linear feedback resistor plus subsequent logarithmic amplifier. This allows to display the logarithm of the probe current over 3 to 4 orders of magnitude (current-voltage characteristic). This compressed form of current display, however, does not allow for a sufficient resolution of small current changes as they occur in time and/or space due to density fluctuations associated with electrostatic waves on instabilities present in a plasma.

In order to measure small electron density fluctuations in the F-region of the Equatorial Ionosphere a digital Langmuir Probe (DLP) was developed at UTD by D. Winningham and J. B. Smith for use in the EQUION rocket project. The unique feature of this experiment is to provide an absolute current resolution of  $\sim 10^{-9}$  Amps and a maximum relative resolution of  $\sim 10^{-4}$ .

Since the investigation of electrostatic wave modes and instabilities is of special interest for laboratory plasma physics, this DLP was installed for use in the plasma chamber at UTD. In particular the digital output of the instrument allowed for a straight forward connection

to the computer (PDP 11/45). Therefore an interface electronics and a set of computer programs were set up to transfer the data to the computer and from there on to magnetic tape and process them for display on a Calcomp plotter.

A general diagram of the system DLP-Computer is shown in Fig. 2. The main parts of the system are described below in more detail.

## II. Properties of the DLP - Electronics\*

A triangular bias waveform is applied at G (see Fig. 3) through the electrometer amplifier (1) to the Probe P. The laboratory version of the DLP allows for using the waveform of either the internal or an external bias generator. The range for the bias voltage is from -1 to +3 volts. The period  $\tau$  of the internal bias generator is controlled by the bit rate fed into the experiment and can be varied between  $.5 \text{ S} \leq \tau \leq 200 \text{ S}$ . The relationship between  $\tau$  and the bit rate  $f_b$  is

$$\tau/\text{S} = \frac{23040}{f_b/\text{Hz}}$$

The electrometer amplifier is a 3420L BURR-BROWN with bias current of about 1 pA and frequency response better than 2 kHz.

The bias waveform at G also appears at A, B, and C. Therefore the bias is also introduced at J so that Amplifier 2 can see the bias as a common mode signal, and can reject it, making D independent of the bias and responsive only to the signal produced by the input current at A. One of the important system tests consists of holding the input current

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\*This chapter is essentially the DLP electronics description that already had been prepared by D. Winningham and J. B. Smith for the EQUION-Project.

constant and letting the bias voltage cycle while observing the output code. If the system is properly adjusted, the output code will not change by more than 1 or 2 LSB's.

The principle of operation is obvious; only a few system constants will be specified here. The A/D converter is a 0 to -10 v full scale, 8 bit unit. Of the total range of 256 increments (called minor increments) only 200 are used, leaving an unused portion at the lower and upper edges of the 10 volt range. The limits of the 200 increment range are determined by voltage comparators. Actually the comparators defined a range of 200 increments plus a hysteresis band of a few increments in order to avoid an oscillatory condition when sitting at band edge. This means that certain values of current can be represented by two different code groups differing by 200 minor increments and by 1 major increment. However, when the two code groups are decoded according to a fixed algorithm, exactly the same current results.

When a voltage comparator switches it changes the D/A converter code by one increment (called a major increment). The resulting output analog increment is fed into the system at J which resets the output D by 200 minor voltage increments.

The D/A is an 8 bit unit in which the 256 increments correspond to an output voltage from -10v to +10v. This range establishes the maximum measuring limits of the system, and  $R_1$  is chosen so that the desired maximum current will cause a  $\pm 10$ v change at B. However the bias voltage must be added to this which results in a range of -11 v to +13 v at B. With a  $\pm 15$  volt supply, the +13 v limit exceeds the linear range of operation of amplifiers 1 and 2. Therefore  $R_1$  is chosen to be 786  $K\Omega$



which results in a maximum voltage at B of  $7.86 \text{ v} + 3\text{V} = 10.86 \text{ v}$  for an input current (electrons) of  $10\mu\text{a}$ . This means that the positive range of the D/A will not all be used. In the negative direction (positive ion current) the maximum current will be even smaller, and is not expected to exceed 15% of the negative range capability.

The sense of the output code is arranged as follows: At the negative limit ( $-10\text{v}$  of positive ion current at B, all code bits are zero. As the current changes so as to move B in a positive direction, the code increases and at  $+10\text{V}$  all bits are 1.

At zero current (0 V at B) the code is

DAC		ADC	
MSB	LSB	MSB	LSB
0 1 1 1	1 1 1 0	1 1 0 0	1 0 0 0

Here the ADC code is 200. It cannot be 0 for zero current because the upper level comparator excludes this point from the operating region. Therefore a major increment is "subtracted" (the DAC LSB = 0) and the ADC increased from 0 to 200.

The code/current algorithm is:

$$i = [(DAC - 127) 200 + ADC] (5 \times 10^{-10}) \text{ where}$$

DAC = the decimal value of the D/a code

ADC = the decimal value of the A/d code

$i$  = amperes (positive  $i$  means electrons flowing to the system. A negative  $i$  means positive ions flowing to the system).

$5 \times 10^{-10}$  = the resolution or amps/minor increment

When applied to the above code the result is:

$$i = [(126 - 127) 200 + 200] (5 \times 10^{-10}) = 0$$

If the current increases by a few minor increments, say 15, the lower level comparator will trip and the resulting code will be:

$$0 \ 1 \ 1 \ 1 \quad 1 \ 1 \ 1 \ 1 \quad 0 \ 0 \ 0 \ 0 \quad 1 \ 1 \ 1 \ 1$$

Applying the algorithm

$$i = 15 (5 \times 10^{-10}) = 75 \times 10^{-10} \text{ a.}$$

The algorithm applies to all values of current.

In reading the value of the analog channel only 1 fact is necessary: The gain of Amplifier 3 is exactly -0.5. If D is -6 v, F is +3v, etc. If the ADC code is known the voltage at D and F can be computed. The ADC increment is  $10\text{v}/256 = 39.0625 \text{ m.v.}$  (40 mv is close enough). Therefore

$$V_D = - (\text{ADC}) .04 \text{ volts}$$

$$V_F = (\text{ADC}) .02 \text{ volts}$$

$$\text{or } \text{ADC} = 50 V_F$$

from which the algorithm can be applied,

$$i = [(\text{DAC} - 127) 200 + 50 V_F] (5 \times 10^{-10}) \text{ amps}$$

### III. The Interface Electronics

The Interface Electronics (IE) provides matching of the experiment output signal to the driver assembly and allows for operation of the DLP in different modes. In more detail the following functions are realized; we partly follow the schematic diagram. Fig. 4 and the timing chart Fig. 5.

- 1) The bit rate is to be provided by an external pulse generator. The word and frame rates are deduced from the bit rate.
- 2) The serial output signal DAC-ADC of the DLP is stored in a 16 bit storage register from where it will later be transferred

in parallel to the computer via 4 each quadruple 2-line to 1-line multiplexers.

- 3) The voltage of the internal or external bias generator is offset by +1.33V and then fed to an A/D-Converter. The A/D-Conversion is ordered by a strobe pulse generated in the programmer.
- 4) The converter is also used for A/D-Conversion of the probe position monitoring voltage (position sweep). This applies for the operation mode of the experiment, in which the probe is kept at constant bias voltage and moved within the plasma.
- 5) A set of eight toggle switches allows for monitoring the experiment number (EXPNO) or a coded STATUS in order to identify a particular data run (measurement).
- 6) Upon a select signal from the programmer the DAC/ADC data or the BIAS (or position)/EXPNO (or STATUS) data is alternately switched by the multiplexers to the driver assembly and then via optical couplers to the receiver section of the computer. Sixteen bits are transferred in parallel to the computer receiver but are not actually read into the computer until a cycle request pulse is generated by the programmer. The rate at which the data points are sampled is 366 per scan. It is independent from the scantime, since both, scantime and sampling period are fixed multiples of the bit period.
- 7) The programmer generated cycle request pulse commands the computer to read the data at its receiver inputs and to then follow the instructions given by the computer program for data storage and/or reduction.

#### IV. The Computer Software

At present the software for the L.P-Computer system consists of three programs

- 1) Storage and Tape Transfer Program (PROBE), ASSEMBLER
- 2) Tape dumping Program (DLP), FORTRAN IV
- 3) Data Analysis Program (DIGITAL LANGMUIR PROBE), FORTRAN IV

PROBE handles the data flux that is coming from the DLP-experiment through the interface electronics IE to the receiver input of the computer. 16 bit data words are stored in the upper core memory and arranged in blocks of 8K Bytes. The part of memory used allows for storage of 22 blocks which form one file. One data block covers the data of 5.5 Scans of the Digital Langmuir Probe. As already mentioned the number of data samples taken per scan is 366 independently of the scantime. Thus with each run (measurement) practically 5 Langmuir Characteristics (each consisting of a full sweep upwards and a full sweep downwards) can be recorded. Prior to each measurement a computer attention button on the IE has to be pushed. This starts the computer to read 8 K bytes of data into the memory. A switch installed at the IE allows to interrupt the data flux.

Once up to 22 data blocks are stored they are transferred on to tape by executing PROBE with one label card for each block. The label card contains additional information (80 bytes) about the particular measurement such as file Number, block number, date and experimental conditions (pressure, probe used, etc). The data sequence on tape is thus: label card information - data block label card information - data block-  
A.S.O. After each 22nd block an End of File (EOF) mark is written on the

tape. When executing PROBE for data transfer on to tape a 00 card inserted right after the label cards takes care of reinitializing the memory so that a new set of 22 measurements can be stored upon pushing the computer intention button.

For short compilation of the procedure in handling the program PROBE see the copy of the printer record in Appendix A.

The Program DLP reads the tape for a selected set of files and blocks and prints the data in 32 columns of octal numbers. The sequence of the data display is

EXPNO - ADC - DAC - BIAS

The selection of file Number (NF) and block (or record) number (NR) is made via a data card which contains the number of records to be read (MAXREX) in column 5, the number of records to be skipped (NRS) in column 10 and the number of files to be skipped (NFS) in column 15.

Fig. 6 shows the flow diagram for this program; a copy of the printer record of DLP is included in appendix B.

The program DIGITAL LANGMUIR PROBE in its present version meets the following objectives:

- 1) Skip a specified number of files and records and print label (or header) card.
- 2) Identify bias and find first bias peak. The bias identification relies on the fixed sequence of DAC/ADC/BIAS/EXPNO and the fact that the experiment number (toggle switch setting at the IE) is constant throughout one run.
- 3) Calculate current  $i$  out of DAC/ADC according to the algorithm given in Chapter II.

- 4) Calculate the derivative  $T_G = 11606.9 \frac{\Delta U}{\Delta \log i}$
- 5) Print EXPNO, Bias, log i and  $T_G$
- 6) Plot data for one cycle (scan) on CALCOMP - Plotter

A simplified flow chart of this program is shown as Fig. 7, a copy of the program is included as appendix C.

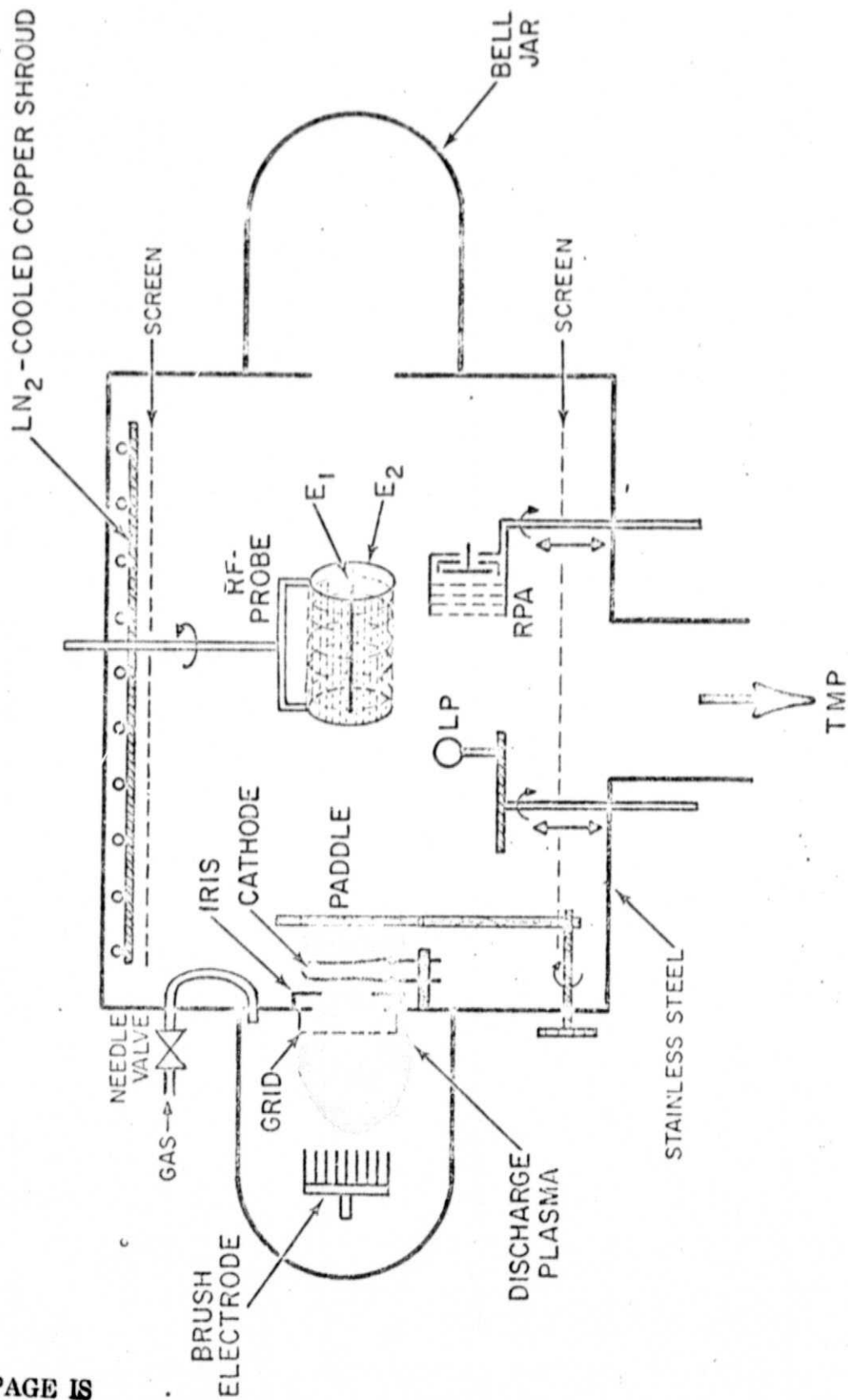
Figs. 8 and 9 show two examples of Langmuir characteristics as semilogarithmic plots produced by the system. The current for increasing bias voltage is marked by x-es, for decreasing bias by squares. The ion current is plotted as log of its absolute value. The probe used in the plasma was a stainless steel sphere of 5 mm diameter. The surface was discharge cleaned for 10 minutes in nitrogen at about  $10\mu$  pressure. The Langmuir curves show almost no hysteresis. In Fig. 8 the floating potential is at +100 mV. In this experiment the plasma was clearly non-Maxwellian since the differential or "generalized temperature"  $T_G$  shows a monotonous increase. Here crosses are for the upward going and triangles for the downward going part of the curve. Fig. 9 shows a case where the distribution function of the electrons is close to Maxwellian. This shows up in the shoulder shaped part of the  $T_G$  - curve, occurring between 1 and 1.4 Volts and corresponding to an electron temperature  $T_e$  of about 5000 K. For an ideally Maxwellian distribution the shoulder would have a horizontal plateau. A high value of  $T_e$  corresponds to a large, a low  $T_e$ -value to a small horizontal extension of the plateau. The low  $T_G$ -values on the left side reflect the drop of the measured total current due to the ion current which becomes significant with decreasing bias voltage. The high  $T_G$ -values on the right side are due to the transition-knee from the retarding to the saturation regime of the

characteristic. This knee is influenced by the inhomogeneity of the work function over the probe surface. A perfectly homogeneous work function would produce a sharper knee of the electron current curve and a correspondingly straightened shape of the  $T_G$ -plateau.

Above 2.5 V bias the data are meaningless since in this case the current exceeded the upper current limit ( $10^{-5}$  amperes) to which the electronics of the Digital Langmuir Probe was set.

**ACKNOWLEDGEMENT:** The author is highly indebted to Dr. D. Winningham for providing the DLP back up electronics of the EQUION-project. Many thanks go to N. Eaker and C. Thompson for designing and building the interface electronics. The outstanding help from Dr. J. Midgley, L. Wadel and D. Beck in providing parts of the necessary software is particularly appreciated. The author finally wishes to express his gratitude to B. Milam for his engineering assistance.





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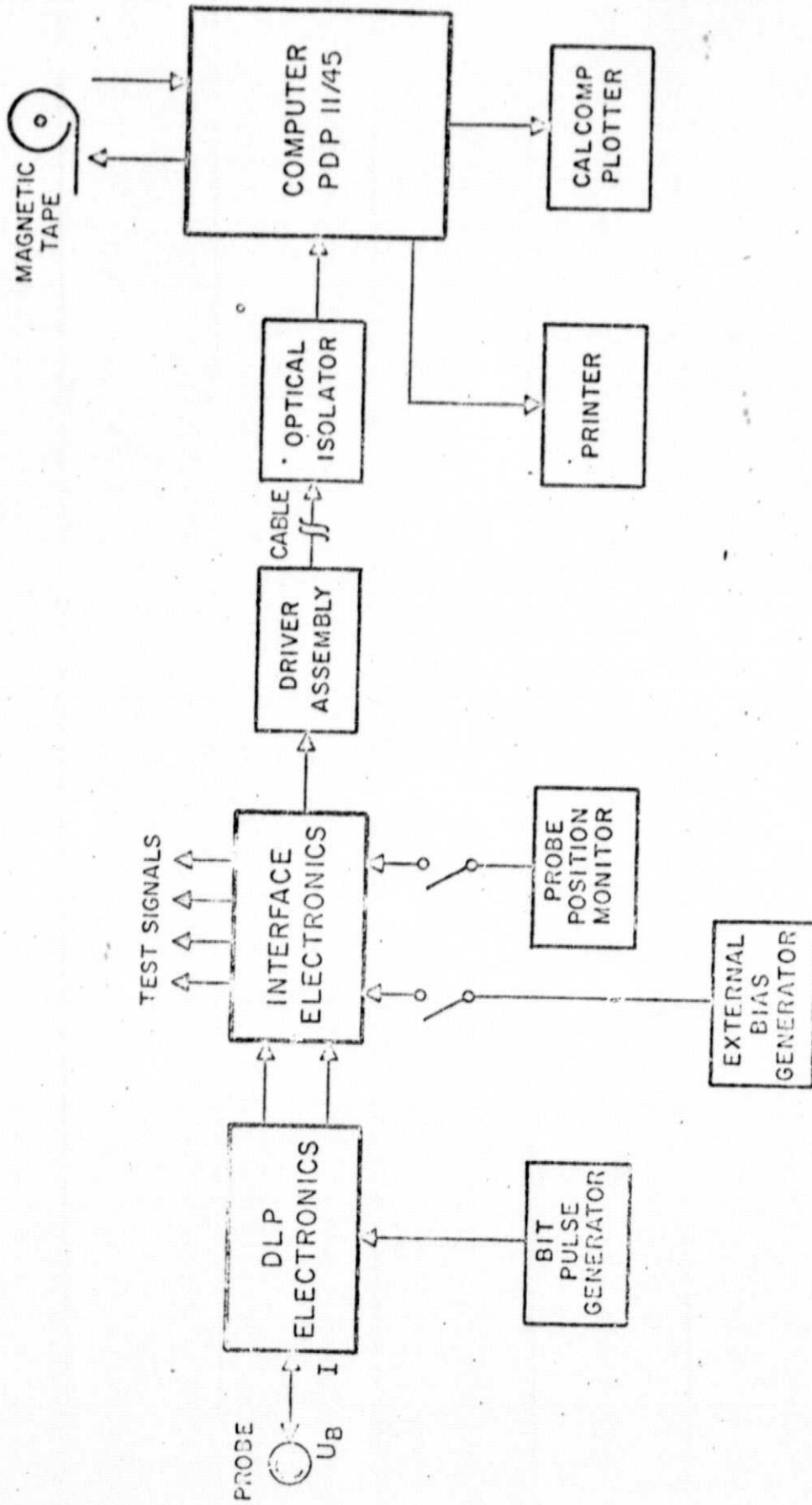


FIG. 2. SYSTEM DLP-COMPUTER

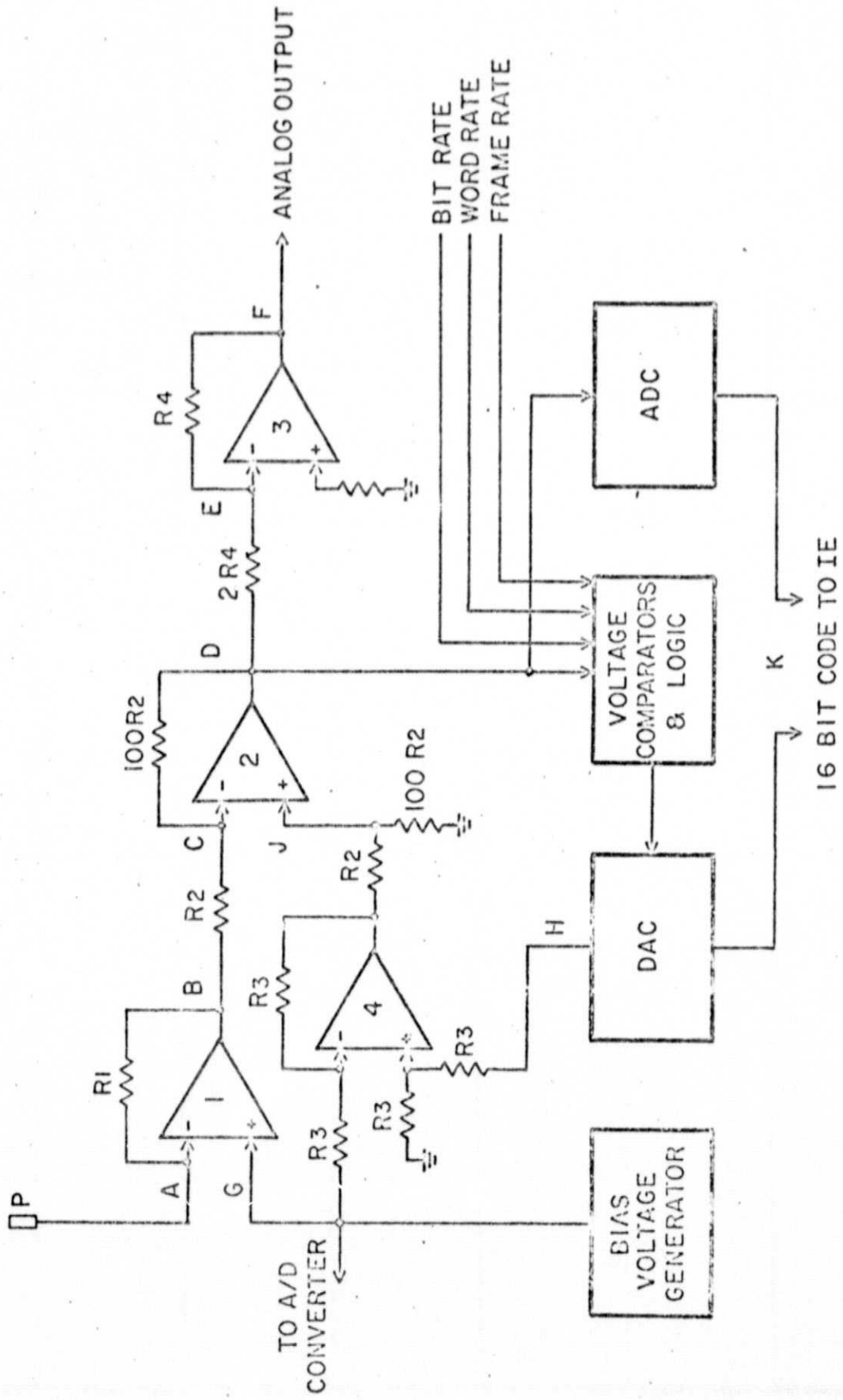
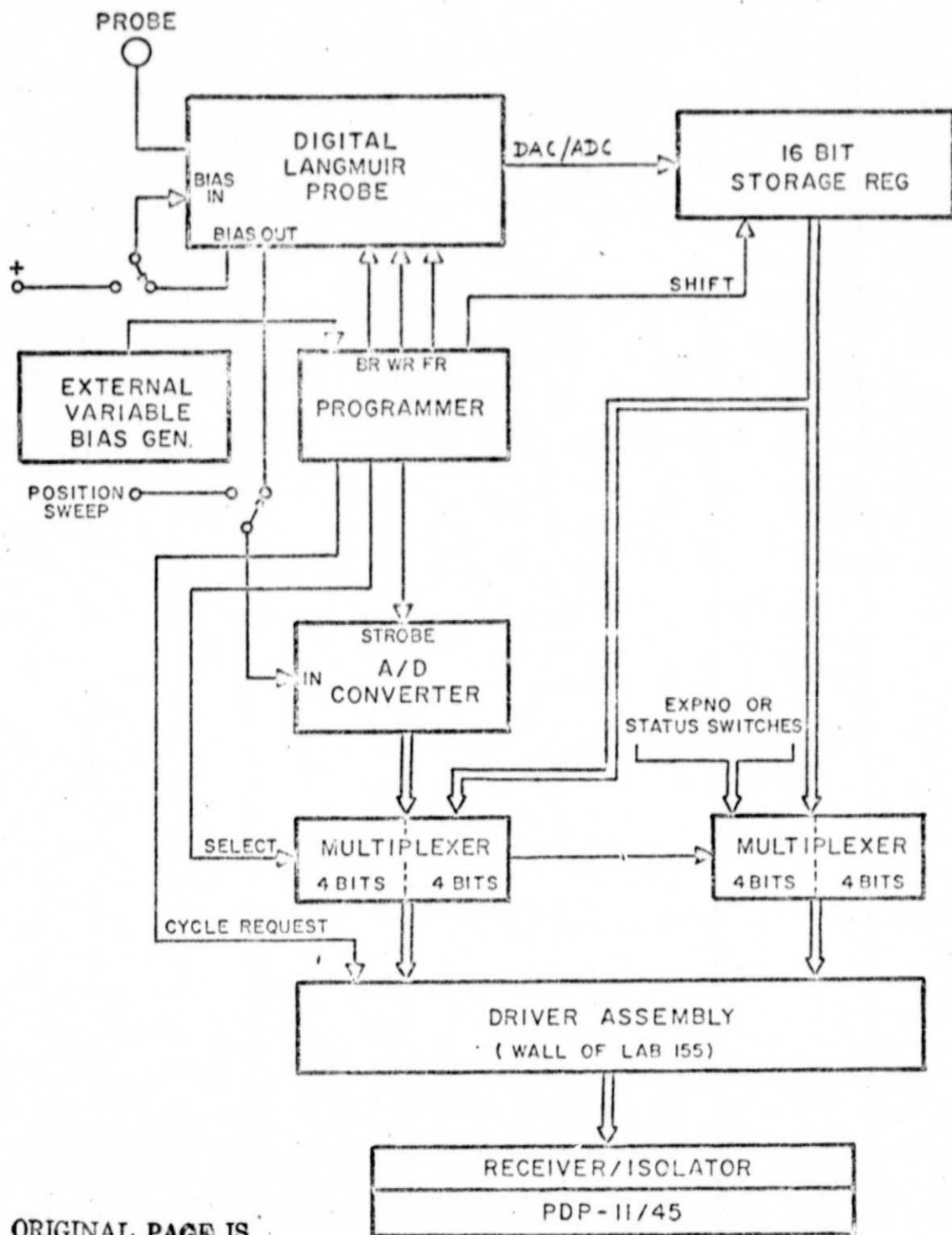


FIG. 3 DIGITAL LANGMUIR PROBE



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FIG. 4

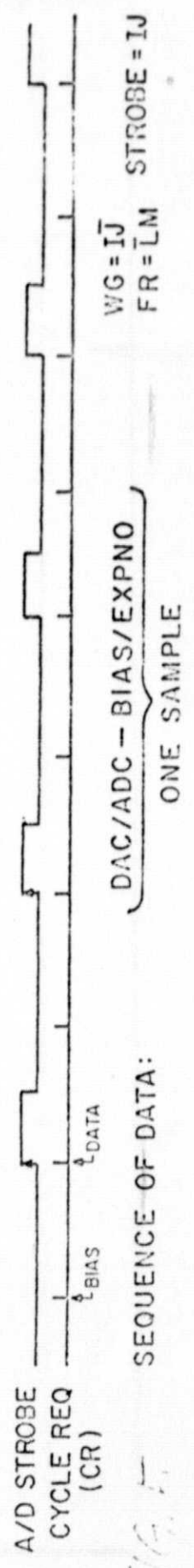
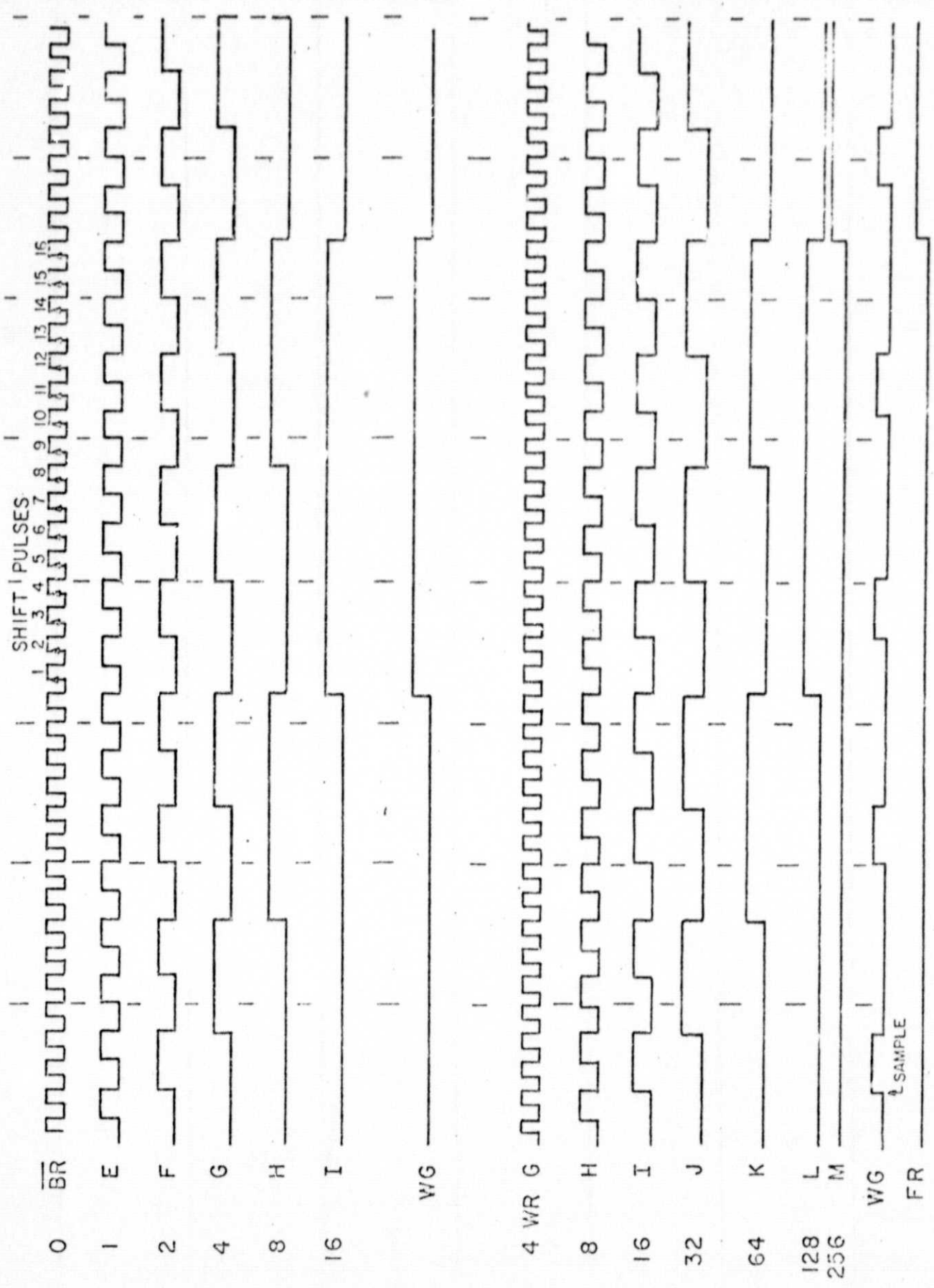


FIG. 5

# DLP tape dumping program

Fortran III

Reads tape, prints data in 32 columns of octal numbers - when decoded, disregard most significant binary digit

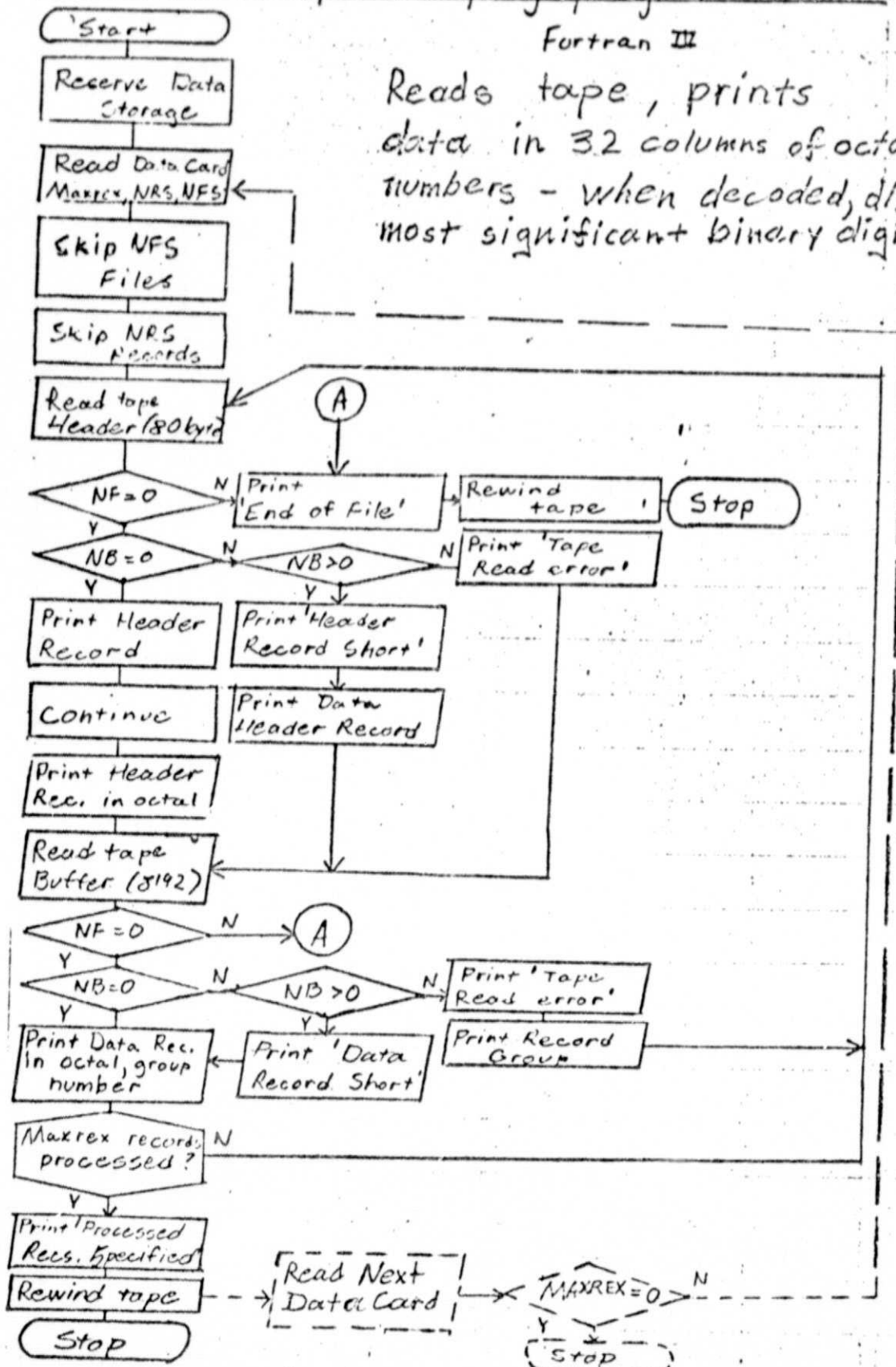
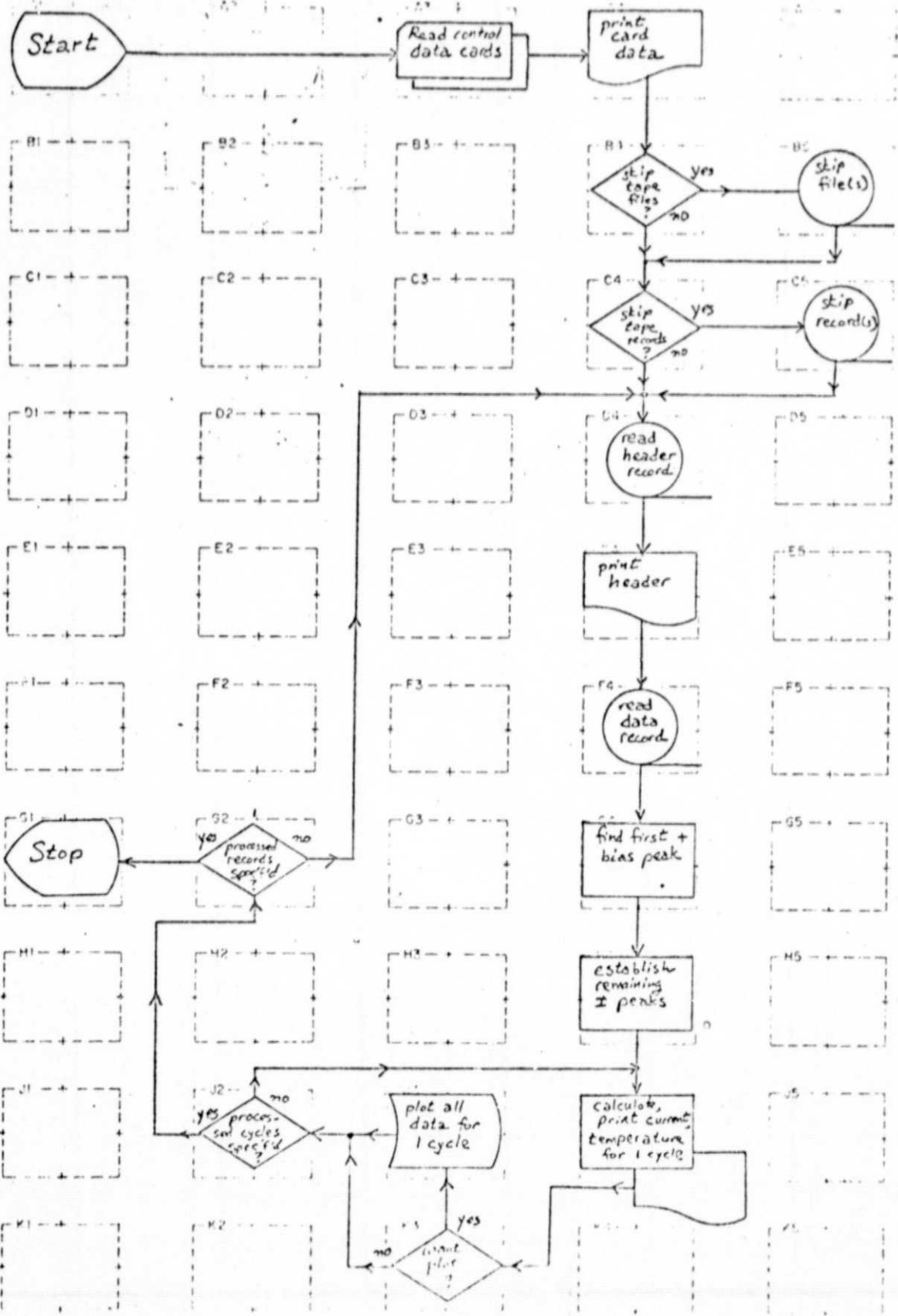


FIG. 6

Programmer: L. B. Wade Program No.: \_\_\_\_\_ Date: 9/25/74 Page: A  
Chart ID: \_\_\_\_\_ Chart Name: \_\_\_\_\_ Program Name: LANGMR

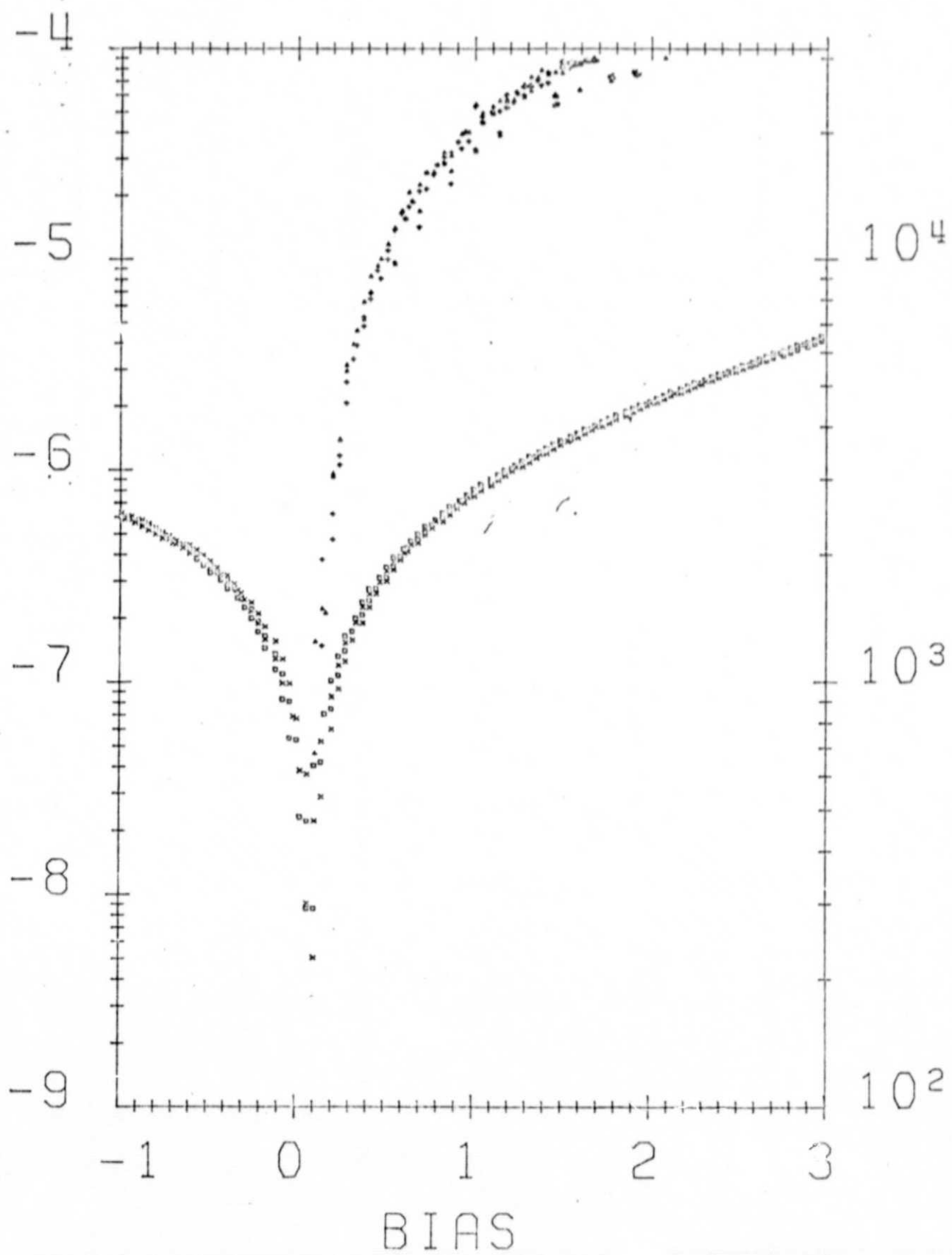


↑  
Fold under at dotted line.

↑  
Fold under at dotted line.

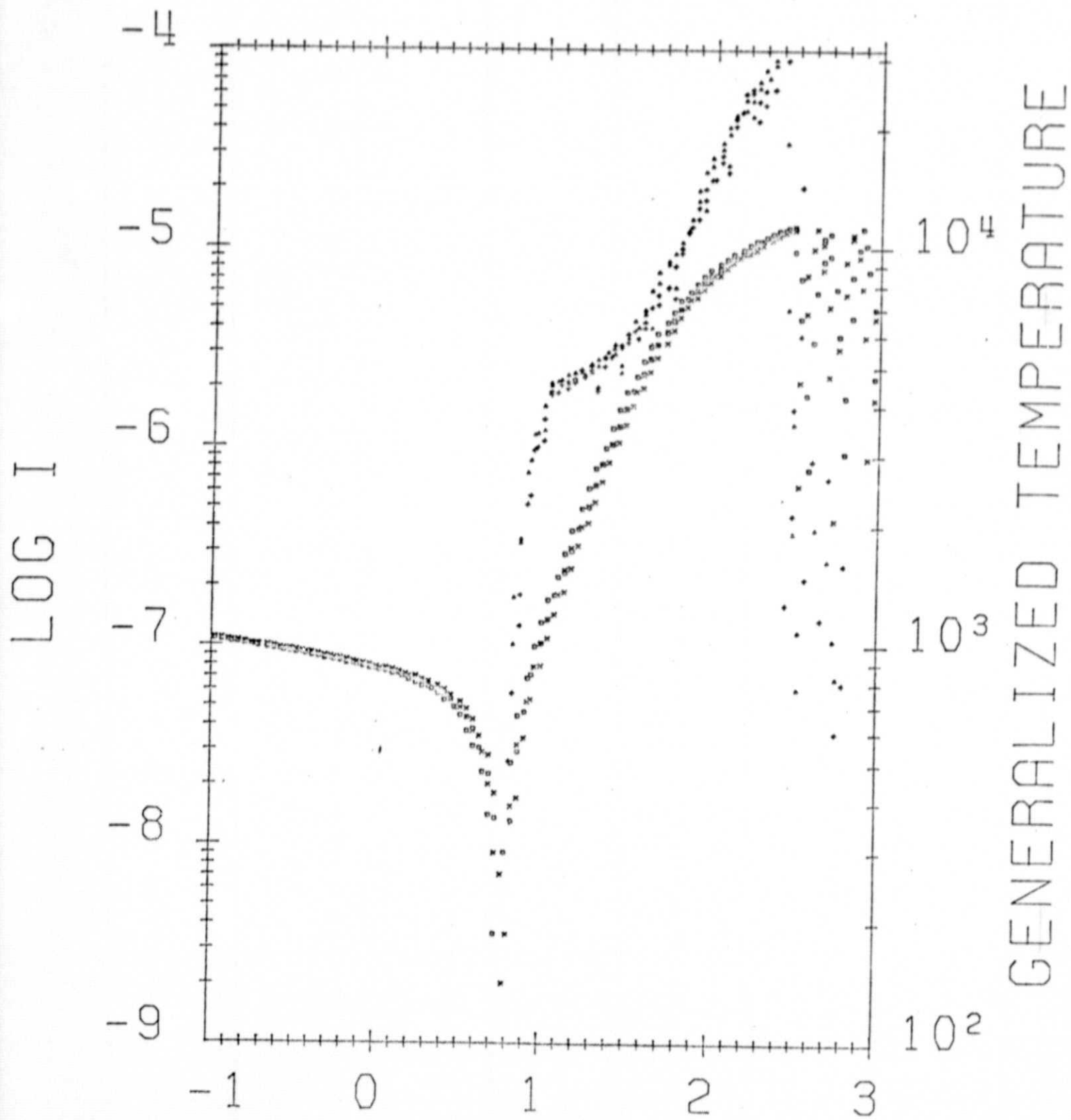


LCG I



EXP NO 192 . FIG. 8





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BIAS

09/26/74 EXP NO 63 FIG. 9

# APPENDIX A

```

1  *LIST ITM
2  *TITLE PROBE
3  I PROBE OPERATES SIMULTANEOUSLY WITH NORMAL BATCH PROCESSING.
4  I IT ACCEPTS 16 BIT DATA WORDS, IN BLOCKS OF 4K WORDS, STORING THEM
5  I IN UPPER MEMORY, AND (WHEN INSTRUCTED) DUMPING THEM ON TAPE AS A FILE
6  I A MAXIMUM OF 22 SUCH BLOCKS MAY BE STORED BETWEEN DUMPS.
7  I WHEN PROBE IS RUN, ONE DATA (LABEL) CARD MUST BE INCLUDED FOR EACH
8  I BLOCK TO BE WRITTEN. THE CONTENTS OF THE CARD ARE WRITTEN AS AN 80
9  I BYTE LABEL RECORD PRECEDING THE 8K BYTE DATA RECORD. THE FIRST TWO
10 I DIGITS ON THE FIRST CARD SPECIFY THE FILE NUMBER IN 10 WHICH THE
11 I BLOCKS ARE WRITTEN. A 90 CARD (CARD WHOSE FIRST TWO COLUMNS ARE ZERO)
12 I FOLLOWING THE LAST LABEL CARD CLOSSES THE FILE AND REINITIALIZES
13 I MEMORY TO STORE ANOTHER 22 BLOCKS.
14
15 I PROCEDURE: 1) EXECUTE PROBE WITH ONLY A 99 CARD, TO INITIAL MEMORY
16 I 2) PUSH ATTENTION BUTTON TO START A DATA BLOCK
17 I 3) START DATA AND STOP IT AFTER 4K WORDS ON CORE.
18 I 4) REPEAT 2) AND 3) UNTIL NO MORE THAN 22 TIMES.
19 I 5) EXECUTE PROBE WITH ONE LABEL CARD FOR EACH BLOCK TO BE
20 I RECORDED ON TAPE, AND A 99 CARD TO REINITIALIZE MEMORY.
21 I 6) REPEAT 2)-5) AS OFTEN AS DESIRED, INCREASING FILE
22 I NUMBER ON LABEL CARDS BY ONE ARCH TIME.
23
24 *GLOBE TAPE
25 *CALLS .INIT, READ, WAIT, RLSE, EXIT
26 *MINI=104 ; THE ADDRESS WHERE INT IS STORED
27
28 PROBEI .INIT *LNKCR
29 161 .HEAD *LNKCR,*CARD ; READ ONE DATA CARD
30 .WAIT *LNKCR
31 MOVH IN,*1
32 MOVH IN+1,*0
33 BAC *17760,*1
34 PIC *17760,*0
35 MUL *12,*1
36 ADD *1,*0 ; ROW FILE NUMBER
37 BR 28
38 BR 128
39 BR 86
40 CLPH 116
41 DEC *1
42 BLE 35
43 MOV *0,*NF ; SKIP NF FILES
44 USR *5,TAPE
45 BR 35
46 *WORD ONE
47 *WORD IC
48 *ACRD IN
49 *WORD ZERO
50 *WORD RM
51 *WORD NF
52 REG 65
53 MOV *12,*NB
54 PIC *60,TAPE,*64 ; SET MEM EXTENSION BITS
55 PIC *60,TAPE,*72
56 USR *5,TAPE ; WRITE LABEL
57 BR 49
58 *WORD IWO
59 *WORD IC

```

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```

58 000156 002674: *WORD IN
59 000160 001020: *WORD NB
60 000162 001050: *WORD NR
61 000164 001600: 4SI MOV ADR,#0 ; GET BUFFER ADDRESS
62 000170 002767: CAC002 000620 ADD #2,ADR
63 000176 010001: MOV #0,#1
64 000200 042700: RIC #17717,#0
65 000204 050057: BIS #0,TAPE+464
66 000210 050057: RIS #0,TAPE+472
67 000214 042701: RIC #17760,#1
68 000220 000301: SWAB #1
69 000222 072127: ASH #4,#1
70 000226 010167: MOV #1,95
71 000232 012767: MOV #20000,NB
72 000240 024567: JSR #5,TAPE ; WRITE DATA BLOCK
73 000244 000415: BR #6
74 000246 001036: *WORD TWO
75 000250 001020: *WORD IC
76 000252 000000: 9SI *WORD
77 000254 001020: *WORD NB
78 000256 001026: *WORD NR
79 000260 004567: 6SI JSR #5,TAPE ; WRITE EOF
80 000264 000415: BR #8
81 000266 001036: *WORD TWO
82 000270 001020: *WORD IC
83 000272 002674: *WORD IN
84 000274 001032: *WORD ZERO
85 000276 001026: *WORD NR
86 000300 005757: 5SI TST NR
87 000304 003240: BGT 15
88 000306 004567: 7SI JSR #5,TAPE ; REWIND THE TAPE OFFLINE
89 000312 000402: BR #8
90 000314 001040: *WORD OFFLIN
91 000316 001020: *WORD IC
92 000320 000320: 8SI RLSE #LNKCR
93 000326 012737: RESET: MOV #MINT,#174 ; SET INTERRUPT ADDRESS
94 000334 012737: 000176 MOV #4340,#176 ; KERNEL, REG SET 1, PRIORITY 7
95 000342 012701: 000516: MOV #MINT,#1
96 000346 012722: 000104: MOV #MINT,#2
97 000352 012720: 000010: MOV #10,#0
98 000356 012122: 9SI: MOV (#1)+,(#2)+ ; MOVE THE INTERRUPT HANDLER INTO RMON
99 000360 077002: SOB #0,95
100 000362 005037: CLR #172340 ; KAC=0
101 000366 012737: 172342 MOV #1000,#172342 ; KAI=1600
102 000374 012737: 172354 MOV #1400,#172354 ; KA6=1400
103 000402 012737: 172356 MOV #7600,#172356 ; KA7=7600
104 000410 012703: 077426 MOV #77426,#3 ; SET PDR FOR 200 BLOCKS, READ-WRITE
105 000414 010337: 172300 MOV #3,#172300 ; KD0
106 000420 010337: 172302 MOV #3,#172302 ; KD1
107 000424 010337: 172314 MOV #3,#172314 ; KD6
108 000430 010337: 172316 MOV #3,#172316 ; KD7
109 000434 012701: 140000 MOV #140000,#1
110 000440 012702: 020000: MOV #20000,#2
111 000444 012700: 010000: MOV #10000,#0
112 000450 012767: 000016 MOV #16,ADR
113 000456 000237: 000001: SPL 7
114 000460 012737: 000001 177572 MOV #1,#177572 ; NNABLE MEM MGMT

```

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115 000456 012122 106: MOV (R1)+, (R2)+ ; MOVE PROGRAM TP UPPER CORE
116 000470 077002 SCB $0,108 ;
117 000472 005037 177572 CLR R#177572 ; CLEAR MEM MGMT
118 000476 000230 SPL 0 ;
119 000500 012737 001600 172354 MOV #1600, R#172354 ; KA6=1600
120 000506 012737 000100 172434 MOV #100, R#172434 ; NNARLE INTERRUPT
121 000514 ; EXIT ; RETURN TO BATCH STREAM TO WAIT FOR A.TN.
122 ; DSABL LSB
123 000516 012737 000001 177572 INT# MOV #1, R#177572 ; NNARLE MEM MGMT
124 000524 000137 000536 JMP R#STORE ;
125 000530 005037 177572 CLR R#177572 ; DISABLE MEM MGMT
126 000534 000002 RFI ;
127 000536 032737 020000 172434 STORE: BIT #20000, R#172434 ; IS ATTN BIT SET?
128 000544 001025 RAE 25 ;
129 000546 012737 000100 172434 MOV #100, R#172434 ; IF NOT, NNARLE INTERRUPT
130 000554 000137 000116 16: JMP R#INT+12 ; AND RETURN TO WAIT
131 000560 032737 020002 172434 28: BIT #20000, R#172434 ; KEEP TESTING ATTENTION BIT
132 000566 021374 BAE 25 ; UNTIL IT IS CLEAR.
133 000570 026727 000222 000072 CMP ADR, #72 ; HAS LAST RUN ALREADY BEEN MADE?
134 000576 002365 RGE 15 ; IF SO, RETURN TO BATCH STREAM.
135 000580 026767 000002 000210 ADD #2, ADR ;
136 000586 016720 MOV ADR, #0 ;
137 000512 010001 MOV #0, #1 ;
138 000614 042721 BIC #17760, #1 SWAB #1 ;
139 000620 000321 ASH #4, #1 ;
140 000622 072127 MOV #1, R#172432 ; SET STARTING ADDRESS
141 000626 010137 172432 MOV #10000, R#172430 ; AND WORD COUNT
142 000632 012737 170000 172430 BIC #17717, #0 ; GET MEM EXT BITS
143 000640 042700 000101 ADD #101, #0 ; COMBINE WITH CONTROL
144 000644 062700 172434 MOV #0, R#172434 ; START ACCEPTING DATA
145 000650 010037 BR 15 ;
146 000654 000737 ;
147 000656 000000 ;
148 000658 114700 ;
149 000662 000001 ;
150 000664 000750 ;
151 000666 000122 000000 000000 ;
152 000674 ;
153 000616 000020 ;
154 000620 000002 ;
155 000622 000123 ;
156 000624 000000 ;
157 000626 000054 ;
158 000630 077777 ;
159 000632 000000 ;
160 000634 177777 ;
161 000636 177776 ;
162 000640 000004 ;
163 000600 ;

```

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SYMBOL TABLE

ADR	P01016R	CARD	000566R	IC	001020R
IN	000674R	INT	000516R	LAKCR	000656R
MINT	000104	NB	P01022R	NF	001024R
NR	001026R	NRM	001030R	OFFLIN	001040R
CNE	001034R	PROBE	000000R	RESET	000320R
SP	0000000	STORE	000536R	TAPE	000000G
T.O	001036R	ZERO	001032R	.SYM	000027

\* ABS. P00000 000  
001042 001

ERRORS DETECTED: 0  
FREE CORE: 12529, WORDS

ERRORS DETECTED: 0  
FREE CORE: 12529, WORDS  
PROBE:LP:PROBE

SRU LINK  
LINK V11AC1  
:PROBE,LP1:PROBE,FTNLB[1,1]/L/E

0  
0  
0  
0  
0  
0  
0  
0  
0  
0



LOAD MAP PROC9E .LDA 10119159-19-SEP-74

TRANSFER ADDRESS: 154724

LOW LIMIT: 154724

HIGH LIMIT: 157468

\*\*\*\*\*

MODULE PROBE

SECTION ADDRESS SIZE

< .ABS.> 000000 000000

< > 154724 001042

\*\*\*\*\*

MODULE TAPE

SECTION ADDRESS SIZE

< > 155766 001472

< > TAPE 155766

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12  
11  
10  
9  
8  
7  
6  
5  
4  
3  
2

LINK V11A01

SRU PROBE

SFI

TIME1-10120121

12  
11  
10  
9  
8  
7  
6  
5  
4  
3  
2



## APPENDIX B

TITLE: DLP

DLP DIRECTIONS!  
 USE DATA CARD TO SPECIFY RECORD READING  
 PUT MAX RECS. COL. 5, NO. RECS. SKIP COL. 10, FILES SKIP COL. 15  
 REPEAT CARDS, USE 0 FOR MAXREX IN LAST CARD.

```

0201  BYTE BUFFER (8192), HEADER(80)
0202  EQUIVALENCE (BUFFER(1), HEADER(1))
0203  4 CONTINUE
0204  N = 0
C     SKIP MODULE
0205  READ (8,1001) MAXREX, NRS, NFS
0206  1001 FORMAT (3I5)
0207  IF (MAXREX.EQ. 0) GO TO 7000
0208  2 IF (NFS.LE. 0) GOTO 5
0209  NB = 0
0210  NR = 50
0211  NF = 1
0212  CALL TAPE(-1,0,BUFFER,NB,NR,NF)
0213  NFS = NFS - 1
0214  GO TO 2
0215  5 CONTINUE
0216  6 IF (NRS.LE. 0) GO TO 10
0217  NB = 0
0218  NR = 2
0219  NF = 1
0220  CALL TAPE(-1,0,BUFFER,NB,NR,NF)
0221  NFS = NFS - 1
0222  GO TO 6
0223  12 CONTINUE
0224  1 NR = 80
0225  NF = 1
0226  NF = 1
0227  IF (N.GT. MAXREX) GO TO 55
0228  3 CALL TAPE (-1, 0, HEADER, NB, NR, NF)
0229  IF (NF.EQ. 0) GO TO 20
0230  IF (NB) 21, 28, 23
0231  20 WRITE (5, 541)
0232  541 FORMAT(1END OF FILE)
0233  GO TO 22
0234  21 WRITE (5,542) N
0235  542 FORMAT(1TAPE READ-ERROR ON HEADER, RECORD=GROUP', I7)
0236  GOTO 200
0237  23 WRITE (5,543) NB, N, HEADER
0238  543 FORMAT(1HEADER RECORD SHORT BY', I3, ', RECORD=GROUP', I7 /
      1 101, 80A1)
0239  GOTO 200
0240  28 WRITE (5,555) HEADER, N
0241  555 FORMAT(101, 80A1, 20X, 1HEADER RECORD GROUP', I7)
C     TEMPORARY! PRINTS OUT OCIAL FORM FOR DIAGNOSES OF TAPE,
C     WRITE (5,955) HEADER
0242

```

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0243 955 FORMAT ('0', 3204)

0244 202 CONTINUE

0245 NB = 8192

0246 NR = 1

0247 NF = 1

0248 CALL TAPE (-1, 2, BUFFER, NB, NR, NF)

0249 IF (NF.EQ.0) GO TO 20

0250 IF (NB) 221, 228, 223

0251 221 WRITE (5,5221) N

0252 5221 FORMAT('1TAPE READ=ERROR ON DATA, RECORD=GROUP', I7)

0253 GO TO 1

0254 223 WRITE (5, 52'3) NB

0255 5223 FORMAT('0DATA RECORD SHORT BY', I7)

0256 228 CONTINUE

0257 WRITE (5,5228) N

0258 5228 FORMAT('0DATA, RECORD=GROUP', I7 //)

0259 WRITE(5,5229)(BUFFER(I),I=1,8000)

0260 5229 FORMAT(' ', 3204)

0261 N = N+1

0262 GO TO 1

0263 55 CONTINUE

0264 WRITE (5,5555)MAXREX

0265 5555 FORMAT('0PROCESSED NUMBER OF RECORDS=GROUPS SPECIFIED',I5)

0266 22 CONTINUE

0267 CALL TAPE (4, 0)

0268 GO TO 4

0269 7000 CONTINUE

0270 STOP

0271 END

8E0D

ROUTINES CALLED:

TAPE

BLOCK LENGTH

MAIN, 4880 (023040)\*

\*\*COMPILER \*\*\*\*\* CORE\*\*

PHASE USED FREE

DECLARATIVES 00456 13034

EXECUTABLES 00607 12883

ASSEMBLY 01471 14936

0  
1  
2  
3  
4  
5  
6  
7  
8  
9

SRU LINK  
LINK V11AG1  
#DLP<DLP,FNLIB(1,1)/L/E  
TRANSFER ADDRESS: 117764  
LOW LIMIT: 117764  
HIGH LIMIT: 157460  
LINK V11AG1

#  
SEOC  
SRU DLP

12  
11  
10  
9  
8  
7  
6  
5  
4  
3  
2

DIGITAL LANGMUIR PROBE

APPENDIX C

DATA CARC #1

NUMINAL MAX PEAK V <sub>0</sub> MIN	(E/F FORMAT)	COLS	1-12
13-24	(E/F )		
25-36	(E/F )		
37-41	(I FORMAT)		
42-46	(I )		

DATA CAMU #2

NUMBER OF FILES TO SKIP (I FORMAT) 1-5

NUMBER OF RECORDS TO SKIP AFTER ANY FILE SKIPPING (COUNT BOTH HEADER RECORDS AND DATA RECORDS) (I ) 6-10

NUMBER OF RECORDS TO PROCESS (COUNT ONLY DATA RECORDS) (I ) 11-15

NUMBER OF CYCLES TO PROCESS (LEAVE BLANK IF WANT ALL) (I ) 16-20

1 IF PLUT WANTED, ELSE 0 OR BLANK IN EACH RECORD (I ) 25

REAL% CURLOG (500), BYAS (500), TE (500), F (500)

INTEGER#2 IDATE(3), IBUF(4096)

INTEGER#2 PEAK (2)

INTEGER#2 INTERM, ADC, DAC, BIAS (4), EXPNR (4)

BYTE HUFFEM(H192), BUF(H192), INTERB(2), HDR(72)

BYTE PBUF (9000)

EQUIVALENCE (HUFFEM(1), BUF(1)), (INTER, INTERB(1)), (HDR(1), BUFFER(1))

EQUIVALENCE (BUF(1), IBUF(1))

DATA NAV / 3 /

DATA ISW / 0 /

DATA BSCALE / 1.95312E-2 /

DATA INTERM / 0 / KHEC / 0 /

DATA TSCALE / 1.16069E4 /

DATA PEAK / 1, 100, /

DATA OFFSET / 1.33 /

FEAC (9,8008) PMAX, PMIN, TOL, LMAX, LMIN

8005 FCMAT (3E12, 0, 215)

WRITE (5,5700) PMAX, PMIN, TOL, LMAX, LMIN

5700 FCMAT (FORBIAS MAX, F8.3, MIN, F8.3, TOLERANCE = F8.3)

1. ASSUMED MAX-TU-MAX, IS, MAX-TO-MIN, IS

READ (8,8005) NF, NH, MAXHEX, KX, IPLT

8005 FCMAT (515)

IF (KX .LE. 0) KX = 19

IF (KX .GT. 19) KX = 19

IF (IPLT .NE. 0)

1CALL CALCMP (PROF, 9000, 53, 0)

WRITE (5,5707) NF

5707 FCMAT (OF FILES SKIPPED = I4)

IF (NF .LE. 0) GO TO 2

NR = 0

NR = 32000

CALL TAPE (-1, 0, BUFFER, NR, MR, NF)

WRITE (5, 5703) NF

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IF (NF, .NE., 0) STOP  
2 CONTINUE  
WRITE (5,5701) MAXREX, NR, KX, IPLT  
5701 FORMAT (10MAX RECORDS, 15, 5X, 'RECORDS SKIPPED', 15, 5X,  
1 'MAX CYCLES PROCESSED PER RECORD', 15, 5X, 'PLOT CODE', 13)  
KX = 2 \* KX - 1

C  
IF (NH, .LE., 0) GO TO 5  
NR = 0  
NF = 1  
CALL TAPE (-1, 0, BUFFER, NB, NR, NF)  
WRITE (5,5702) NH  
5702 FORMAT (10AFTER SKIPPING, NR DECREMENTED TO, 13)  
5 CONTINUE  
IF (KREC, .EQ., MAXREX) GO TO 888  
HEAD HDR RECORD, WAIT FOR COMPLETION

C  
KREC = KREC + 1  
NR = 80  
NF = 1  
NF = 1  
CALL TAPE (-1, 0, BUFFER, NB, NR, NF)  
EUF?  
C  
IF (NF, .NE., 1) GO TO 999  
READ ERROR OR SHORT RECORD?  
C  
IF (NH) 10, 20, 30  
GOOD RECORD

C 20 CONTINUE  
WRITE (5,5005) MOP, KREC  
5005 FORMAT (1, 72A1, 20X, 'RECORD NO.', 15, //)  
C  
SAVE DATE FROM HEADER RECORD TO PLOT  
DO 25 I = 1, 3  
25 IDATE (I) = IBUF (I+1)  
HEAD DATA RECORD \* WT FOR COMP.

C 300 CONTINUE  
NR = 8192  
NF = 1  
NF = 1  
CALL TAPE (-1, 0, BUFFER, NB, NR, NF)  
C  
IF (NF, .NE., 1) GOTO 999  
READ ERROR OR SHORT RECORD?  
C  
IF (NR) 310, 320, 330  
GOOD RECORD

C 320 CONTINUE  
C  
J = 3  
DO 40 I = 6, 18, \*  
IF (IBUF (2), .NE., BUF (I)) GO TO 50  
40 CONTINUE  
DO 45 I = 402, 418, \*  
IF (IBUF (2), .NE., BUF (I)) GO TO 50  
45 CONTINUE  
GO TO 60

C 50 CONTINUE  
J = 5  
DO 55 I = 8, 20, \*  
IF (IBUF (4), .NE., BUF (I)) GO TO 70  
55 CONTINUE  
DO 75 I = 404, 420, \*  
IF (IBUF (4), .NE., BUF (I)) GO TO 70  
75 CONTINUE  
GO TO 60  
70 CONTINUE



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C 60 CONTINUE

INTERH(1) = RUF(J-1)  
EXPNR(1) = INTER  
WRITE (5, 5015) EXPNR(1)  
5015 FORMAT('EXPERIMENT-NUMBER', 05, ' OCTAL')  
C FIND POSITIVE BIAS PEAK

DO 80 I = J, 8117, 4  
INTER (1) = RUF(I+3)  
IF (INTER .NE. EXPNR(1)) GO TO 120  
INTERB (1) = RUF(I+2)  
BIAS(1) = INTER  
BYE = BSCALE\*BIAS(1)  
IF (BYE .GE. (PHAX-TOL)) GO TO 100

80 CONTINUE  
120 CONTINUE  
WRITE (5, 5020)  
5020 FORMAT('PEAK NOT FOUND')  
GO TO 5

100 CONTINUE  
INTERB (1) = RUF (I + 6)  
IF (INTER .LT. BIAS (1)) GO TO 110  
BIAS (1) = INTER  
I = I + 4

GO TO 100  
110 CONTINUE  
MAXMIN(1) = I + 2  
DO 210 I = 2, 40

210 MAXMIN(I) = 0  
DO 220 I = 2, 38, 2  
MAXMIN(I) = MAXMIN(I-1) + 4 \* LMIN  
ITEMP = MAXMIN(I-1) + 4 \* LMAX  
IF (ITEMP .GE. 4191) GO TO 230

INTERH(1) = RUF(ITEMP+1)  
IF (INTER .EQ. EXPNR(1)) GO TO 240  
INTERH(1) = RUF(ITEMP + 41)  
IF (INTER .NE. EXPNR(1)) GO TO 230  
240 MAXMIN(I+1) = ITEMP

220 CONTINUE  
230 CONTINUE  
C TABULATE BIAS, DAC, ADC, F STARTING AT FIRST POSITIVE PEAK  
C DAC IS IN BUF(I+5) ADC BUF(I+4)  
C BIAS BUF(I+6) EXPNR BUF(I+7)  
C

DO 200 K = 1, KK+2  
KU = MAXMIN (K+2)  
IF (KU .EQ. 0) GO TO 5  
KM = MAXMIN (K+1)  
KL = MAXMIN (K)  
LCTR = 99  
N = 0

DO 400 KK = KL, KU, 4  
N = N + 1  
IF (KK .EQ. KM) NMID = N  
INTERH(1) = BUF (KK-2)  
ADC = INTER  
INTERH(1) = BUF (KK-1)  
DAC = INTER  
F(N) = (DAC - 127) \* 200 + ADC + 5.E-10  
FABS = ABS (F(N))  
IF (FABS .EQ. 0.) FABS = 1.E-35  
CURLOG (N) = ALOG10 (FABS)  
INTERH(1) = BUF (KK)  
N = N + 1

```

C
BIAS (N) = BSCALE * BIAS(1) - OFFSET
INIT TE SO CAN DETECT LATER IF ACTUALLY CALCULATED
TE (N) = 1.E-35
400 CONTINUE
NMAX = N
N = 0
DO 180 KK = KL, KU, 4
LCTR = LCTH + 1
IF (LCTR .LT. 50) GO TO 130
LCTH = 0
WRITE (5, 5080)
5080 FORMAT(1HYTE PT BIAS EXP# DAC_ADC CURRENT,
1, LOG(CURRENT), DELTA_LOG ADJ_BIAS DELTA_BIAS,
2, TE, //)
130 CONTINUE
N = N + 1
KP = 1
IF ((KK.EQ. KL).OR. (KK.EQ. KM).OR. (KK.EQ. KU)) KP = 2
INTERH(1) = BUF (KK-2)
ADC = INTER
INTERB(1) = HUF (KK-1)
DAC = INTER
INTERH(1) = HUF (KK)
BIAS(1) = INTER
ITEMP = NAV + 1
IF (N .LT. ITEMP) GO TO 140
ITEMP = NMAX - NAV
IF (N .GT. ITEMP) GO TO 140
DO 420 J = 1, NAV
JJ = NAV + 1 - J
FP = F(N + JJ)
FM = F(N - JJ)
IF ((FP .GT. 0.) .AND. (FM .GT. 0.)) GO TO 430
420 CONTINUE
GO TO 140
430 CONTINUE
DCLOG = CURLOG (N + JJ) - CURLOG (N - JJ)
IF (DCLOG .EQ. 0.) GO TO 140
DRYAS = HYAS (N + JJ) - HYAS (N - JJ)
TE (N) = ABS (TSCALE * DRYAS / DCLOG)
WRITE (5, 5035) KK, N, BIAS(1), EXPNR(1), PEAK(KP),
1 DAC, ADC, F(N), CURLOG(N), DCLOG, BYAS(N), DRYAS, TE(N)
5035 FORMAT(1, 214, 15.054X, A1, 215, 1P6E13.5)
GO TO 180
140 CONTINUE
WRITE (5, 5025) KK, N, BIAS(1), EXPNR(1), PEAK(KP),
1 DAC, ADC, F(N), CURLOG(N), BYAS(N)
5025 FORMAT(1, 214, 15.054X, A1, 215, 1P2E13.5, 13X, E13.5)
180 CONTINUE
IF (IPLT .EQ. 0) GO TO 200
IF (ISW .NE. 0) CALL CALCMP (12., 0., 0., 2)
ISW = 1
DRAW AXES
CALL XYAXES (EXPNR(1), IDATE)
CALL PLCUR (CURLOG, BYAS, NMID, NMAX)
CALL PLTEM (TE, BYAS, NMID, NMAX)
LET INK DRY
CALL CALCMP (0., 0., 0., 2)
200 CONTINUE
GO TO 5
C
10 CONTINUE
WRITE (5, 5110) NREC
5110 FORMAT(1TAP# HEAD#ERROR# RECORD NO., 15)

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30 CONTINUE
WRITE (5, 5130) NH, KREC, MDX
5130 FORMAT ('TAPE RECORD SHORT BY', I8, 10X, 'RECORD NO.', I5,
10, 72A1)
GOTO 300
310 CONTINUE
WRITE (5, 5110) KREC
GO TO 5
330 CONTINUE
WRITE (5, 5330) NH, KREC, BUF
5330 FORMAT ('TAPE RECORD SHORT BY', I8, 10X, 'RECORD NO.',
115, (' ', 320+))
GO TO 5
C
PROCESSED MAXHEX RECORDS
888 CONTINUE
WRITE (5, 5888)
5888 FORMAT ('COMPLETED RECORDS SPECIFIED')
STOP
C
999 CONTINUE
WRITE (5, 5999)
5999 FORMAT ('TAPE END-OF-FILE')
STOP
END
SUBROUTINE PLCUR (CURLG, BYAS, NMID, NMAX)
REAL*4 CURLG(500), BYAS(500)
DATA C / 1.25 /
DATA D / J. /
DATA ISYMN / 91 /
DATA ISYMP / 95 /
DATA A / 1.5 /
DATA B / 16.5 /
C
DO 100 I = 1, NMAX
TRANSFORM ALL BYAS AS MAY BEED IN SUBRTN PLTEM
BYAS(I) = C * BYAS(I) + D
IF ((BYAS(I) .LT. 1.75) .OR. (BYAS(I) .GT. 6.75)) GO TO 100
IF ((CURLG(I) .GT. -4.) .OR. (CURLG(I) .LT. -9.)) GO TO 100
CURLG(I) = A * CURLG(I) + B
ISYM = ISYMN
IF (I .GT. NMID) ISYM = ISYMP
CALL SYMBOL (BYAS(I), CURLG(I), 0.05, ISYM, 0., -1)
100 CONTINUE
C
RETURN
END
SUBROUTINE PLTEM (TE, BYAS, NMID, NMAX)
REAL*4 TE(500), BYAS(500)
DATA ISYMN / 93 /
DATA ISYMP / 94 /
DATA A / 3.0 /
DATA B / -3.0 /
DATA CUT / 6.5 /
CUT MUST CHANGE IF C, D IN SUBRTN PLCUR CHANGE
BYAS HAS BEEN TRANSFORMED BY IMMEDIATELY PREVIOUS CALL PLCUR
DO 100 I = 1, NMAX
IF (BYAS(I) .GT. CUT) GO TO 100
IF ((TE(I) .GT. 3.00000E4) .OR. (TE(I) .LT. 100.)) GO TO 100
TE(I) = A * ALG10 (TE(I)) + B
ISYM = ISYMN
IF (I .GT. NMID) ISYM = ISYMP
CALL SYMBOL (BYAS(I), TE(I), 0.05, ISYM, 0., -1)
100 CONTINUE
RETURN
END

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INTEGEMO2 IDATE (3)  
INTEGEMO2 NCD (5)  
DATA ISYM / 31 /  
DATA AL / 1.75 /  
DATA YB / 3. /  
DATA XSCALE / 0.125 /  
DATA XH / 6.75 /  
DATA TSCALE / 3. /  
DATA CSCALE / 1.5 /  
DATA TL / 0.301030, 0.477121, 0.602060, 0.698970, 0.778151,  
1 0.845098, 0.903090, 0.954243 /

C

FPN = -1.  
CALL NUMBER (XL=0.100, YH=0.500, 0.250, FPN, 0., -1)  
DUPLICATE TO ENSURE INK START  
CALL NUMBER (XL=0.100, YB=0.500, 0.250, FPN, 0., -1)  
K = 0  
CALL CALCMP (XL, YB, 0, 1)

DO 22 I = 1, 4  
DO 18 J = 1, 9  
K = K + 1  
X = AL + K \* XSCALE  
CALL SYMBOL (X, YB, 0.14, ISYM, 0., -2)  
18 CONTINUE

K = K + 1  
X = AL + K \* XSCALE  
CALL SYMBOL (X, YB, 0.28, ISYM, 0., -2)  
FPN = I - 1  
CALL NUMBER (X = 0.100, YH=0.500, 0.250, FPN, 0., -1)  
CALL CALCMP (X, YB, 0, 1)

22 CONTINUE  
FPN = 10.  
CALL NUMBER (XH=0.25, YB, 0.25, FPN, 0., -1)  
FPN = 2.  
CALL NUMBER (999., YB=0.125, 0.15, FPN, 0., -1)  
CALL CALCMP (XH, YB, 0, 1)  
DO 28 I = 1, 3  
JJ = 8

IF (I.EQ.3) J = 2  
DO 26 J = 1, JJ  
Y = YB + TSCALE \* (TL(J) + I - 1)  
CALL SYMBOL (XH, Y, 0.1, ISYM, 90., -2)  
26 CONTINUE  
IF (I.EQ.3) GO TO 28  
Y = YB + I \* TSCALE

CALL SYMBOL (XH, Y, 0.28, ISYM, 90., -2)  
FPN = 10.  
CALL NUMBER (XH=0.25, Y, 0.25, FPN, 0., -1)  
FPN = 1+2  
CALL NUMBER (999., Y+0.125, 0.15, FPN, 0., -1)  
CALL CALCMP (XH, Y, 0, 1)  
28 CONTINUE  
YSV = Y

FPN = -9.  
CALL NUMBER (XL=0.75, YB, 0.25, FPN, 0., -1)  
CALL CALCMP (XL, YB, 0, 1)  
DO 38 I = 1, 5  
DO 36 J = 1, 8  
Y = YB + CSCALE \* (TL(J) + I - 1)  
CALL SYMBOL (XL, Y, 0.14, ISYM, 90., -2)

36 CONTINUE  
Y = YB + I \* CSCALE  
CALL SYMBOL (XL, Y, 0.28, ISYM, 90., -2)  
FPN = I - 9  
CALL NUMBER (XL=0.75, Y, 0.25, FPN, 0., -1)

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38 CONTINUE

K = 0

DO 42 I = 1, 4

DO 48 J = 1, 9

K = K + 1

X = XL + K \* XSCALE

CALL SYMBOL (X, Y, 0.14, ISYM, 0., -2)

48 CONTINUE

K = K + 1

X = XL + K \* XSCALE

CALL SYMBOL (X, Y, 0.28, ISYM, 0., -2)

42 CONTINUE

CALL CALCOMP (XH, YSV, 1, 1)

CALL SYMBOL (AL-1.20, YH-3.0, 0.30, 'LOG I', 90., 5)

CALL SYMBOL (AL-1.9, YH-1.0, 0.25, 'BIAS', 0., 4)

CALL SYMBOL (AH-1.35, YB-0.5, 0.30, 'GENERALIZED TEMPERATURE',

1 90., 23)

CALL SYMBOL (AL, YH-1.50, 0.250, IDATE(1), 0., 2)

CALL SYMBOL (999., YH-1.50, 0.250, ' ', 0., 1)

CALL SYMBOL (999., YH-1.50, 0.250, IDATE(2), 0., 2)

CALL SYMBOL (999., YB-1.50, 0.250, ' ', 0., 1)

CALL SYMBOL (999., YB-1.50, 0.250, IDATE(3), 0., 2)

E=CODE (10, 7000, NCD) NEXP

7000 FORMAT ('EXP NO', I4)

CALL SYMBOL (AH-2.50, YB-1.50, 0.250, NCD, 0., 10)

RETURN

END